

TLV910x 16-V, 1-MHz, Rail-to-Rail Input/Output, Low Power Op Amp

1 Features

- Rail-to-rail input and output
- Wide bandwidth: 1.1-MHz GBW
- Low quiescent current: 120 μA per amplifier
- Low offset voltage: $\pm 300 \mu\text{V}$
- Low offset voltage drift: $\pm 0.6 \mu\text{V}/^\circ\text{C}$
- Low noise: $28 \text{ nV}/\sqrt{\text{Hz}}$ at 10 kHz
- High common-mode rejection: 110 dB
- Low bias current: $\pm 10 \text{ pA}$
- High slew rate: $4.5 \text{ V}/\mu\text{s}$
- Wide supply: $\pm 1.35 \text{ V}$ to $\pm 8 \text{ V}$, 2.7 V to 16 V
- Robust EMIRR performance: 77 dB at 1.8 GHz

2 Applications

- [Optical modules](#)
- [Portable test and measurement](#)
- [Macro remote radio unit \(RRU\)](#)
- [Baseband unit \(BBU\)](#)
- [Appliances](#)

3 Description

The TLV910x family (TLV9101, TLV9102, and TLV9104) is a family of 16-V general purpose operational amplifiers. This family offers excellent DC precision and AC performance, including rail-to-rail input/output, low offset ($\pm 300 \mu\text{V}$, typ), low offset drift ($\pm 0.5 \mu\text{V}/^\circ\text{C}$, typ), and 1.1-MHz bandwidth.

Wide differential and common-mode input-voltage range, high output current ($\pm 80 \text{ mA}$), high slew rate ($4.5 \text{ V}/\mu\text{s}$), low power operation ($120 \mu\text{A}$, typ) and shutdown functionality make the TLV910x a robust, low-power, high-performance operational amplifier for industrial applications.

The TLV910x family of op amps is available in *micro*-size packages, as well as standard packages, and is specified from -40°C to 125°C .

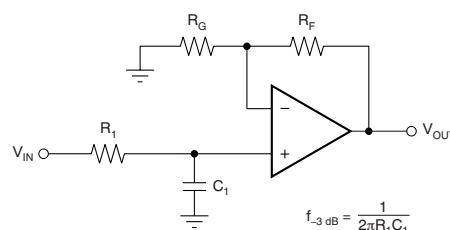
Device Information⁽¹⁾

| PART NUMBER | PACKAGE | BODY SIZE (NOM) |
|-------------|----------------------------|-------------------|
| TLV9101 | SOT-23 (5) | 2.90 mm × 1.60 mm |
| | SOT-23 (6) | 2.90 mm × 1.60 mm |
| | SC70 (5) | 2.00 mm × 1.25 mm |
| | SOT-553 (5) ⁽²⁾ | 1.60 mm × 1.20 mm |
| TLV9102 | SOIC (8) | 4.90 mm × 3.90 mm |
| | SOT-23 (8) ⁽²⁾ | 2.90 mm × 1.60 mm |
| | TSSOP (8) | 3.00 mm × 4.40 mm |
| | VSSOP (8) ⁽²⁾ | 3.00 mm × 3.00 mm |
| | VSSOP (10) | 3.00 mm × 3.00 mm |
| | WSON (8) | 2.00 mm × 2.00 mm |
| | X2QFN (10) | 1.50 mm × 1.50 mm |
| TLV9104 | SOIC (14) | 8.65 mm × 3.90 mm |
| | TSSOP (14) | 5.00 mm × 4.40 mm |
| | WQFN (16) ⁽²⁾ | 3.00 mm × 3.00 mm |
| | X2QFN (14) ⁽²⁾ | 2.00 mm × 2.00 mm |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

(2) This package is preview only.

TLV910x in a Single-Pole, Low-Pass Filter



$$f_{-3 \text{ dB}} = \frac{1}{2\pi R_1 C_1}$$

$$\frac{V_{\text{OUT}}}{V_{\text{IN}}} = \left(1 + \frac{R_F}{R_G}\right) \left(\frac{1}{1 + sR_1 C_1}\right)$$



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4 Revision History

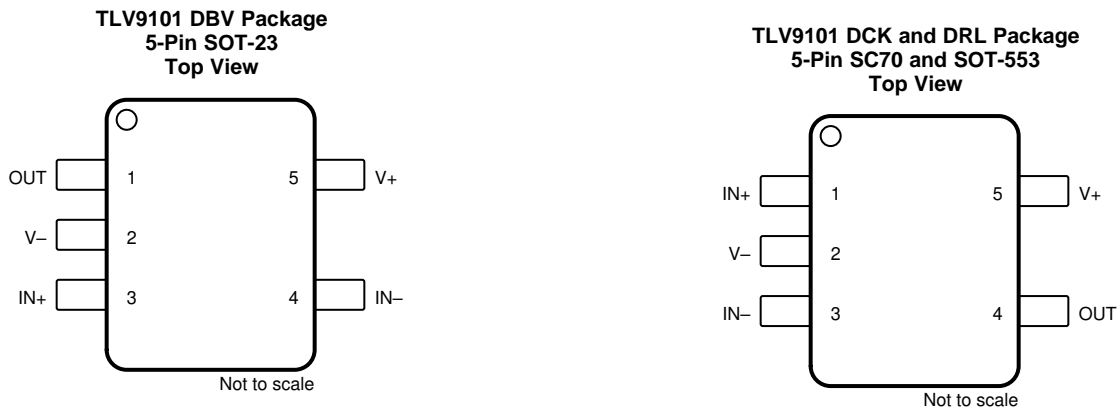
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Changes from Revision B (January 2020) to Revision C | Page |
|--|-------------|
| • Removed preview notation from TLV9102 VSSOP (10) package from <i>Device Information</i> table | 1 |
| • Removed preview notation from TLV9102 X2QFN (10) package from <i>Device Information</i> table..... | 1 |
| • Removed preview notation from TLV9102 DGS package (VSSOP) in the <i>Pin Configuration and Functions</i> section..... | 5 |
| • Removed preview notation from TLV9102 RUG package (X2QFN) in the <i>Pin Configuration and Functions</i> section..... | 5 |

| Changes from Revision A (April 2019) to Revision B | Page |
|--|-------------|
| • Changed the TLV9101 and TLV9104 device statuses from <i>Advance Information</i> to <i>Production Data</i> | 1 |
| • Removed preview notation from TLV9101 SOT-23 (5) package from <i>Device Information</i> table | 1 |
| • Removed preview notation from TLV9101 SOT-23 (6) package from <i>Device Information</i> table | 1 |
| • Removed preview notation from TLV9101 SC70 (5) package from <i>Device Information</i> table..... | 1 |
| • Removed preview notation from TLV9102 TSSOP (8) package from <i>Device Information</i> table | 1 |
| • Removed preview notation from TLV9102 WSON (8) package from <i>Device Information</i> table | 1 |
| • Removed preview notation from TLV9104 SOIC (14) package from <i>Device Information</i> table..... | 1 |
| • Removed preview notation from TLV9104 TSSOP(14) package from <i>Device Information</i> table | 1 |
| • Removed preview notation from TLV9102 DSG package (WSON) in the <i>Pin Configuration and Functions</i> section | 4 |
| • Added SHUTDOWN to <i>Electrical Characteristics</i> | 12 |
| • Added <i>Packages With an Exposed Thermal Pad</i> to the <i>Feature Description</i> | 29 |

| Changes from Original (February 2019) to Revision A | Page |
|---|-------------|
| • Changed the TLV9102 device status from <i>Advance Information</i> to <i>Production Data</i> | 1 |
| • Removed preview notation from TLV9102 SOIC (8) package from <i>Device Information</i> table..... | 1 |

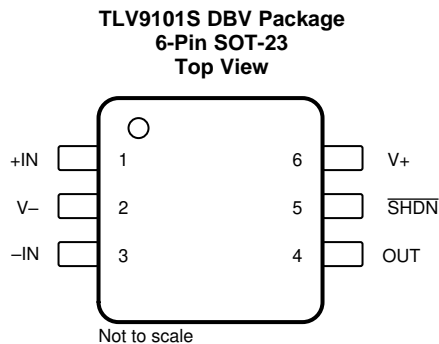
5 Pin Configuration and Functions



(1) Package is preview only.

Pin Functions: TLV9101

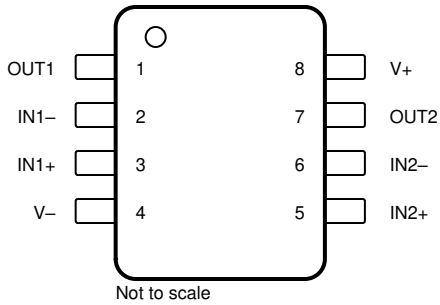
| NAME | PIN | | I/O | DESCRIPTION |
|------|-----|-------------|-----|---------------------------------|
| | DBV | DCK and DRL | | |
| +IN | 3 | 1 | I | Noninverting input |
| -IN | 4 | 3 | I | Inverting input |
| OUT | 1 | 4 | O | Output |
| V+ | 5 | 5 | — | Positive (highest) power supply |
| V- | 2 | 2 | — | Negative (lowest) power supply |



Pin Functions: TLV9101S

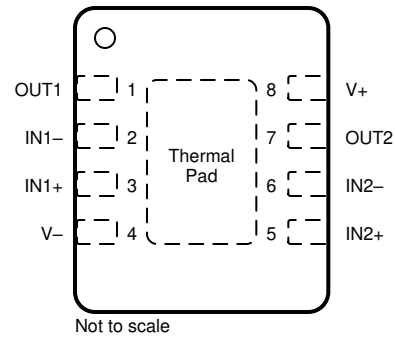
| NAME | PIN | | I/O | DESCRIPTION |
|------|-----|--|-----|--|
| | DBV | | | |
| IN+ | 3 | | I | Noninverting input |
| IN- | 4 | | I | Inverting input |
| OUT | 1 | | O | Output |
| SHDN | 5 | | I | Shutdown: low = amplifier enabled, high = amplifier disabled. See the Shutdown section for more information. |
| V+ | 6 | | — | Positive (highest) power supply |
| V- | 2 | | — | Negative (lowest) power supply |

TLV9102 D, DDF, DGK, and PW Package⁽¹⁾
8-Pin SOIC, SOT-23, TSSOP, and VSSOP
Top View



(1) DDF and DGK packages are preview only.

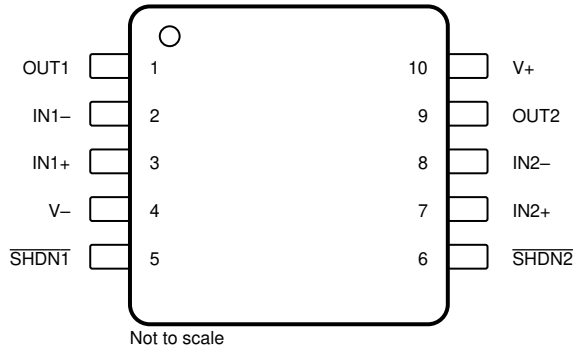
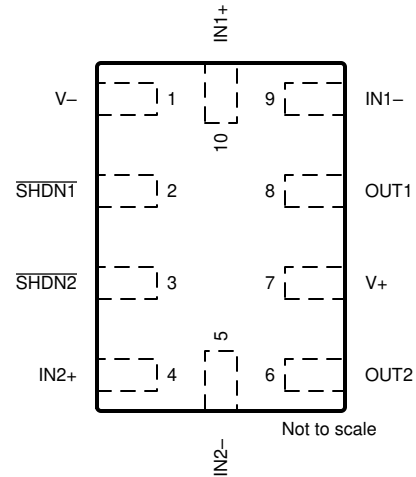
TLV9102 DSG Package⁽¹⁾
8-Pin WSON With Exposed Thermal Pad
Top View



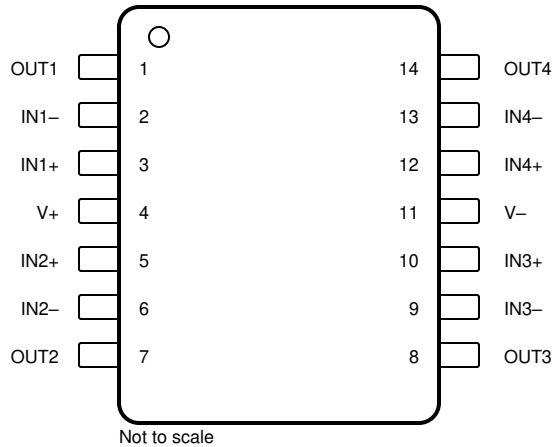
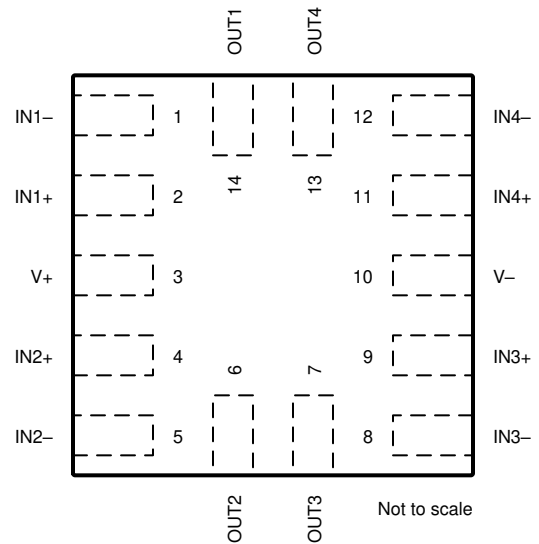
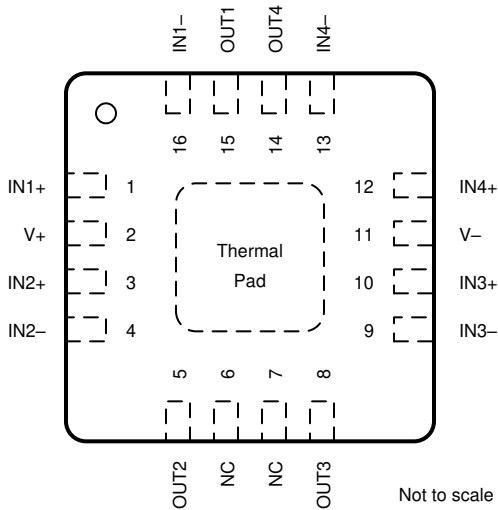
(1) Connect thermal pad to V-. See the [Packages With an Exposed Thermal Pad](#) section for more information.

Pin Functions: TLV9102

| PIN | | I/O | DESCRIPTION |
|------|--------------------------------------|-----|---------------------------------|
| NAME | SOIC, SOT-23, TSSOP, VSSOP, and WSON | | |
| IN1+ | 3 | I | Noninverting input, channel 1 |
| IN1- | 2 | I | Inverting input, channel 1 |
| IN2+ | 5 | I | Noninverting input, channel 2 |
| IN2- | 6 | I | Inverting input, channel 2 |
| OUT1 | 1 | O | Output, channel 1 |
| OUT2 | 7 | O | Output, channel 2 |
| V+ | 8 | — | Positive (highest) power supply |
| V- | 4 | — | Negative (lowest) power supply |

**TLV9102S DGS Package
10-Pin VSSOP
Top View**

**TLV9102S RUG Package
10-Pin X2QFN
Top View**

Pin Functions: TLV9102S

| NAME | PIN | | I/O | DESCRIPTION |
|-------|-------|-------|-----|---|
| | VSSOP | X2QFN | | |
| IN1+ | 3 | 10 | I | Noninverting input, channel 1 |
| IN1- | 2 | 9 | I | Inverting input, channel 1 |
| IN2+ | 7 | 4 | I | Noninverting input, channel 2 |
| IN2- | 8 | 5 | I | Inverting input, channel 2 |
| OUT1 | 1 | 8 | O | Output, channel 1 |
| OUT2 | 9 | 6 | O | Output, channel 2 |
| SHDN1 | 5 | 2 | I | Shutdown, channel 1: low = amplifier enabled, high = amplifier disabled. See the Shutdown section for more information. |
| SHDN2 | 6 | 3 | I | Shutdown, channel 2: low = amplifier enabled, high = amplifier disabled. See the Shutdown section for more information. |
| V+ | 10 | 7 | — | Positive (highest) power supply |
| V- | 4 | 1 | — | Negative (lowest) power supply |

**TLV9104 D and PW Package
14-Pin SOIC and TSSOP
Top View**

**TLV9104 RUC Package⁽¹⁾
14-Pin WQFN With Exposed Thermal Pad
Top View**

**TLV9104 RTE Package⁽²⁾
16-Pin WQFN With Exposed Thermal Pad
Top View**


(1) Package is preview only.

(1) Connect thermal pad to V-. See the [Packages With an Exposed Thermal Pad](#) section for more information.

(2) Package is preview only.

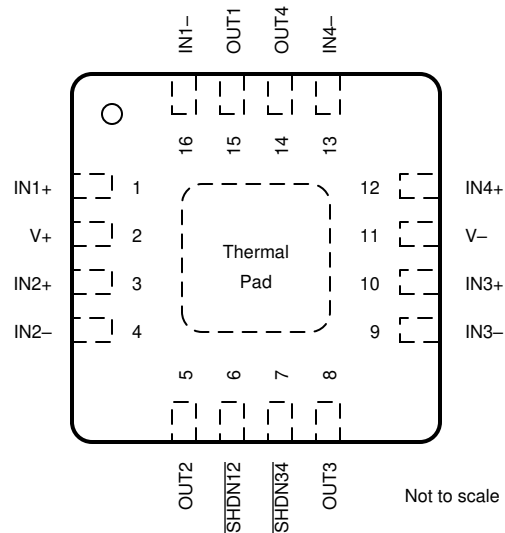
Pin Functions: TLV9104

| NAME | PIN | | | I/O | DESCRIPTION |
|------|----------------|------|-------|-----|-------------------------------|
| | SOIC and TSSOP | WQFN | X2QFN | | |
| IN1+ | 3 | 1 | 2 | I | Noninverting input, channel 1 |
| IN1- | 2 | 16 | 1 | I | Inverting input, channel 1 |
| IN2+ | 5 | 3 | 4 | I | Noninverting input, channel 2 |
| IN2- | 6 | 4 | 5 | I | Inverting input, channel 2 |
| IN3+ | 10 | 10 | 9 | I | Noninverting input, channel 3 |
| IN3- | 9 | 9 | 8 | I | Inverting input, channel 3 |

Pin Functions: TLV9104 (continued)

| NAME | PIN | | | I/O | DESCRIPTION |
|------|----------------|------|-------|-----|---------------------------------|
| | SOIC and TSSOP | WQFN | X2QFN | | |
| IN4+ | 12 | 12 | 11 | I | Noninverting input, channel 4 |
| IN4– | 13 | 13 | 12 | I | Inverting input, channel 4 |
| NC | — | 6, 7 | — | — | Do not connect |
| OUT1 | 1 | 15 | 14 | O | Output, channel 1 |
| OUT2 | 7 | 5 | 6 | O | Output, channel 2 |
| OUT3 | 8 | 8 | 7 | O | Output, channel 3 |
| OUT4 | 14 | 14 | 13 | O | Output, channel 4 |
| V+ | 4 | 2 | 3 | — | Positive (highest) power supply |
| V– | 11 | 11 | 10 | — | Negative (lowest) power supply |

TLV9104S RTE Package⁽¹⁾
16-Pin WQFN With Exposed Thermal Pad
Top View



- (1) Connect thermal pad to V-. See [Packages With an Exposed Thermal Pad](#) section for more information.
- (2) Package is preview only.

Pin Functions: TLV9104S

| PIN | | I/O | DESCRIPTION |
|--------|------|-----|--|
| NAME | WQFN | | |
| IN1+ | 1 | I | Noninverting input, channel 1 |
| IN1– | 16 | I | Inverting input, channel 1 |
| IN2+ | 3 | I | Noninverting input, channel 2 |
| IN2– | 4 | I | Inverting input, channel 2 |
| IN3+ | 10 | I | Noninverting input, channel 3 |
| IN3– | 9 | I | Inverting input, channel 3 |
| IN4+ | 12 | I | Noninverting input, channel 4 |
| IN4– | 13 | I | Inverting input, channel 4 |
| OUT1 | 15 | O | Output, channel 1 |
| OUT2 | 5 | O | Output, channel 2 |
| OUT3 | 8 | O | Output, channel 3 |
| OUT4 | 14 | O | Output, channel 4 |
| SHDN12 | 6 | I | Shutdown, channels 1 and 2: low = amplifiers enabled, high = amplifiers disabled. See the Shutdown section for more information. |
| SHDN34 | 7 | I | Shutdown, channels 3 and 4: low = amplifiers enabled, high = amplifiers disabled. See the Shutdown section for more information. |
| VCC+ | 2 | — | Positive (highest) power supply |
| VCC– | 11 | — | Negative (lowest) power supply |

6 Specifications

6.1 Absolute Maximum Ratings

over operating ambient temperature range (unless otherwise noted)⁽¹⁾

| | | MIN | MAX | UNIT |
|--------------------------------------|-------------------------------------|--------------|--------------|------|
| Supply voltage, $V_S = (V+) - (V-)$ | | 0 | 20 | V |
| Signal input pins | Common-mode voltage ⁽²⁾ | $(V-) - 0.5$ | $(V+) + 0.5$ | V |
| | Differential voltage ⁽²⁾ | | $V_S + 0.2$ | V |
| | Current ⁽²⁾ | -10 | 10 | mA |
| Output short-circuit ⁽³⁾ | | Continuous | | |
| Operating ambient temperature, T_A | | -55 | 150 | °C |
| Junction temperature, T_J | | | 150 | °C |
| Storage temperature, T_{stg} | | -65 | 150 | °C |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) Input pins are diode-clamped to the power-supply rails. Input signals that may swing more than 0.5 V beyond the supply rails must be current limited to 10 mA or less.
- (3) Short-circuit to ground, one amplifier per package.

6.2 ESD Ratings

| | | | VALUE | UNIT |
|-------------|-------------------------|--|-------|------|
| $V_{(ESD)}$ | Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾ | ±2000 | V |
| | | Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾ | ±1000 | |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating ambient temperature range (unless otherwise noted)

| | | MIN | MAX | UNIT |
|-------|-------------------------------|--------------|--------------|------|
| V_S | Supply voltage, $(V+) - (V-)$ | 2.7 | 16 | V |
| V_I | Input voltage range | $(V-) - 0.2$ | $(V+) + 0.2$ | V |
| T_A | Specified temperature | -40 | 125 | °C |

6.4 Thermal Information for Single Channel

| THERMAL METRIC ⁽¹⁾ | | TLV9101, TLV9101S | | | | UNIT |
|-------------------------------|--|-------------------|--------|------------|------------------------------|------|
| | | DBV (SOT-23) | | DCK (SC70) | DRL ⁽²⁾ (SOT-553) | |
| | | 5 PINS | 6 PINS | 5 PINS | 5 PINS | |
| $R_{\theta JA}$ | Junction-to-ambient thermal resistance | 192.2 | 1174.6 | 204..7 | TBD | °C/W |
| $R_{\theta JC(top)}$ | Junction-to-case (top) thermal resistance | 113.7 | 113.5 | 116.6 | TBD | °C/W |
| $R_{\theta JB}$ | Junction-to-board thermal resistance | 60.6 | 55.9 | 51.9 | TBD | °C/W |
| Ψ_{JT} | Junction-to-top characterization parameter | 37.4 | 39.7 | 24.9 | TBD | °C/W |
| Ψ_{JB} | Junction-to-board characterization parameter | 60.4 | 55.7 | 51.6 | TBD | °C/W |
| $R_{\theta JC(bot)}$ | Junction-to-case (bottom) thermal resistance | N/A | N/A | N/A | TBD | °C/W |

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).
- (2) This package option is preview for TLV9101.

6.5 Thermal Information for Dual Channel

| THERMAL METRIC ⁽¹⁾ | | TLV9102, TLV9102S | | | | | | | UNIT |
|-------------------------------|--|-------------------|-------------------------------|----------------------------|----------------------------|------------|------------|-------------|------|
| | | D (SOIC) | DDF ⁽²⁾ (SOT-23-8) | DGK ⁽²⁾ (VSSOP) | DGS ⁽²⁾ (VSSOP) | DSG (WSON) | PW (TSSOP) | RUG (X2QFN) | |
| | | 8 PINS | 8 PINS | 8 PINS | 10 PINS | 8 PINS | 8 PINS | 10 PINS | |
| R _{θJA} | Junction-to-ambient thermal resistance | 138.7 | TBD | TBD | 152.2 | 81.6 | 188.4 | 149.6 | °C/W |
| R _{θJC(top)} | Junction-to-case (top) thermal resistance | 78.7 | TBD | TBD | 67.3 | 101.6 | 77.1 | 58.3 | °C/W |
| R _{θJB} | Junction-to-board thermal resistance | 82.2 | TBD | TBD | 95.5 | 48.3 | 119.1 | 77.7 | °C/W |
| Ψ _{JT} | Junction-to-top characterization parameter | 27.8 | TBD | TBD | 67.9 | 6.0 | 14.2 | 1.3 | °C/W |
| Ψ _{JB} | Junction-to-board characterization parameter | 81.4 | TBD | TBD | 94.3 | 48.3 | 117.4 | 77.5 | °C/W |
| R _{θJC(bot)} | Junction-to-case (bottom) thermal resistance | N/A | TBD | TBD | N/A | 22.8 | N/A | N/A | °C/W |

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).
- (2) This package option is preview for TLV9102.

6.6 Thermal Information for Quad Channel

| THERMAL METRIC ⁽¹⁾ | | TLV9104, TLV9104S | | | | UNIT |
|-------------------------------|--|-------------------|------------|---------------------------|---------------------------|------|
| | | D (SOIC) | PW (TSSOP) | RTE ⁽²⁾ (WQFN) | RUC ⁽²⁾ (WQFN) | |
| | | 14 PINS | 14 PINS | 16 PINS | 14 PINS | |
| R _{θJA} | Junction-to-ambient thermal resistance | 105.2 | 134.7 | 53.5 | 143.0 | °C/W |
| R _{θJC(top)} | Junction-to-case (top) thermal resistance | 61.2 | 55.0 | 58.3 | 46.4 | °C/W |
| R _{θJB} | Junction-to-board thermal resistance | 61.1 | 79.0 | 28.6 | 81.8 | °C/W |
| Ψ _{JT} | Junction-to-top characterization parameter | 21.4 | 9.2 | 2.1 | 1.0 | °C/W |
| Ψ _{JB} | Junction-to-board characterization parameter | 60.7 | 78.1 | 28.6 | 81.5 | °C/W |
| R _{θJC(bot)} | Junction-to-case (bottom) thermal resistance | N/A | N/A | 12.6 | N/A | °C/W |

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).
- (2) This package option is preview for TLV9104.

6.7 Electrical Characteristics

For $V_S = (V+) - (V-) = 2.7\text{ V to }16\text{ V}$ ($\pm 1.35\text{ V to } \pm 8\text{ V}$) at $T_A = 25^\circ\text{C}$, $R_L = 10\text{ k}\Omega$ connected to $V_S / 2$, $V_{CM} = V_S / 2$, and $V_{OUT} = V_S / 2$, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | | MIN | TYP | MAX | UNIT |
|----------------------------|--|--|--|--|--------------|--------------------------------------|
| OFFSET VOLTAGE | | | | | | |
| V_{OS} | Input offset voltage | $V_{CM} = V-$ | | ± 0.3 | ± 1.5 | mV |
| | | | $T_A = -40^\circ\text{C to }125^\circ\text{C}$ | | ± 1.75 | |
| dV_{OS}/dT | Input offset voltage drift | | | ± 0.6 | | $\mu\text{V}/^\circ\text{C}$ |
| PSRR | Input offset voltage versus power supply | $V_{CM} = V-$ | $T_A = -40^\circ\text{C to }125^\circ\text{C}$ | ± 0.1 | ± 0.7 | $\mu\text{V}/\text{V}$ |
| | | | | | | |
| | Channel separation | $f = 0\text{ Hz}$ | | 5 | | $\mu\text{V}/\text{V}$ |
| INPUT BIAS CURRENT | | | | | | |
| I_B | Input bias current | | | ± 10 | | pA |
| I_{OS} | Input offset current | | | ± 5 | | pA |
| NOISE | | | | | | |
| E_N | Input voltage noise | $f = 0.1\text{ Hz to }10\text{ Hz}$ | | 6 | | μV_{PP} |
| | | | | 1 | | μV_{RMS} |
| e_N | Input voltage noise density | $f = 1\text{ kHz}$ | | 30 | | $\text{nV}/\sqrt{\text{Hz}}$ |
| | | $f = 10\text{ kHz}$ | | 28 | | |
| i_N | Input current noise | $f = 1\text{ kHz}$ | | 2 | | $\text{fA}/\sqrt{\text{Hz}}$ |
| INPUT VOLTAGE RANGE | | | | | | |
| V_{CM} | Common-mode voltage range | | $(V-) - 0.2$ | | $(V+) + 0.2$ | V |
| CMRR | Common-mode rejection ratio | $V_S = 16\text{ V}, (V-) - 0.1\text{ V} < V_{CM} < (V+) - 2\text{ V}$ (Main input pair) | $T_A = -40^\circ\text{C to }125^\circ\text{C}$ | 90 | 110 | dB |
| | | $V_S = 4\text{ V}, (V-) - 0.1\text{ V} < V_{CM} < (V+) - 2\text{ V}$ (Main input pair) | | 75 | 95 | |
| | | $V_S = 2.7 - 16\text{ V}, (V+) - 1\text{ V} < V_{CM} < (V+) + 0.1\text{ V}$ (Aux input pair) | | | 80 | |
| | | $(V+) - 2\text{ V} < V_{CM} < (V+) - 1\text{ V}$ | | See Offset Voltage (Transition Region) | | |
| INPUT CAPACITANCE | | | | | | |
| Z_{ID} | Differential | | | $100 \parallel 3$ | | $\text{M}\Omega \parallel \text{pF}$ |
| Z_{ICM} | Common-mode | | | $6 \parallel 1$ | | $\text{T}\Omega \parallel \text{pF}$ |
| OPEN-LOOP GAIN | | | | | | |
| A_{OL} | Open-loop voltage gain | $V_S = 16\text{ V}, V_{CM} = V- (V-) + 0.1\text{ V} < V_O < (V+) - 0.1\text{ V}$ | $T_A = -40^\circ\text{C to }125^\circ\text{C}$ | 115 | 135 | dB |
| | | $V_S = 4\text{ V}, V_{CM} = V- (V-) + 0.1\text{ V} < V_O < (V+) - 0.1\text{ V}$ | | 104 | 125 | dB |
| FREQUENCY RESPONSE | | | | | | |
| GBW | Gain-bandwidth product | | | 1.1 | | MHz |
| SR | Slew rate | $V_S = 16\text{ V}, G = +1, C_L = 20\text{ pF}$ | | 4.5 | | $\text{V}/\mu\text{s}$ |
| t_s | Settling time | To 0.1%, $V_S = 16\text{ V}, V_{STEP} = 10\text{ V}, G = +1, C_L = 20\text{ pF}$ | | 4 | | μs |
| | | To 0.1%, $V_S = 16\text{ V}, V_{STEP} = 2\text{ V}, G = +1, C_L = 20\text{ pF}$ | | 2 | | |
| | | To 0.01%, $V_S = 16\text{ V}, V_{STEP} = 10\text{ V}, G = +1, C_L = 20\text{ pF}$ | | 5 | | |
| | | To 0.01%, $V_S = 16\text{ V}, V_{STEP} = 2\text{ V}, G = +1, C_L = 20\text{ pF}$ | | 3 | | |
| | Phase margin | $G = +1, R_L = 10\text{ k}\Omega, C_L = 20\text{ pF}$ | | 60 | | $^\circ$ |
| | Overload recovery time | $V_{IN} \times \text{gain} > V_S$ | | 600 | | ns |
| THD+N | Total harmonic distortion + noise | $V_S = 16\text{ V}, V_O = 1\text{ V}_{RMS}, G = -1, f = 1\text{ kHz}$ | | 0.0028% | | |

Electrical Characteristics (continued)

For $V_S = (V+) - (V-) = 2.7\text{ V to }16\text{ V}$ ($\pm 1.35\text{ V to } \pm 8\text{ V}$) at $T_A = 25^\circ\text{C}$, $R_L = 10\text{ k}\Omega$ connected to $V_S / 2$, $V_{CM} = V_S / 2$, and $V_{OUT} = V_S / 2$, unless otherwise noted.

| PARAMETER | TEST CONDITIONS | | MIN | TYP | MAX | UNIT |
|--------------------------------|--|--|--|-----------------------|-----|--------------------------------------|
| OUTPUT | | | | | | |
| Voltage output swing from rail | Positive and negative rail headroom | $V_S = 16\text{ V}$, $R_L = \text{no load}$ | | 3 | | mV |
| | | $V_S = 16\text{ V}$, $R_L = 10\text{ k}\Omega$ | | 45 | 60 | |
| | | $V_S = 16\text{ V}$, $R_L = 2\text{ k}\Omega$ | | 200 | 300 | |
| | | $V_S = 2.7\text{ V}$, $R_L = \text{no load}$ | | 1 | | |
| | | $V_S = 2.7\text{ V}$, $R_L = 10\text{ k}\Omega$ | | 5 | 20 | |
| | | $V_S = 2.7\text{ V}$, $R_L = 2\text{ k}\Omega$ | | 25 | 50 | |
| I_{SC} | Short-circuit current | | | ± 80 | | mA |
| C_{LOAD} | Capacitive load drive | | See Typical Characteristics | | | |
| Z_O | Open-loop output impedance | $f = 1\text{ MHz}$, $I_O = 0\text{ A}$ | | 600 | | Ω |
| POWER SUPPLY | | | | | | |
| I_Q | Quiescent current per amplifier | $I_O = 0\text{ A}$ | | 115 | 150 | μA |
| | | | $T_A = -40^\circ\text{C to }125^\circ\text{C}$ | | 160 | |
| SHUTDOWN | | | | | | |
| I_{QSD} | Quiescent current per amplifier | $V_S = 2.7\text{ V to }16\text{ V}$, all amplifiers disabled, $\overline{\text{SHDN}} = V-$ | | 20 | 30 | μA |
| Z_{SHDN} | Output impedance during shutdown | $V_S = 2.7\text{ V to }16\text{ V}$, amplifier disabled | | 10 12 | | $\text{G}\Omega \parallel \text{pF}$ |
| V_{IH} | Logic high threshold voltage (amplifier enabled) | | | $(V-) + 1.1\text{ V}$ | | V |
| V_{IL} | Logic low threshold voltage (amplifier disabled) | | | $(V-) + 0.2\text{ V}$ | | V |
| t_{ON} | Amplifier enable time ⁽¹⁾ | $G = +1$, $V_{CM} = V-$, $V_O = 0.1 \times V_S / 2$ | | 11 | | μs |
| t_{OFF} | Amplifier disable time ⁽¹⁾ | $V_{CM} = V-$, $V_O = V_S / 2$ | | 2.5 | | μs |
| | SHDN pin input bias current (per pin) | $V_S = 2.7\text{ V to }40\text{ V}$, $(V-) + 20\text{ V} \geq \text{SHDN} \geq (V-) + 0.9\text{ V}$ | | 500 | | nA |
| | | $V_S = 2.7\text{ V to }40\text{ V}$, $(V-) \leq \text{SHDN} \leq (V-) + 0.7\text{ V}$ | | 150 | | |

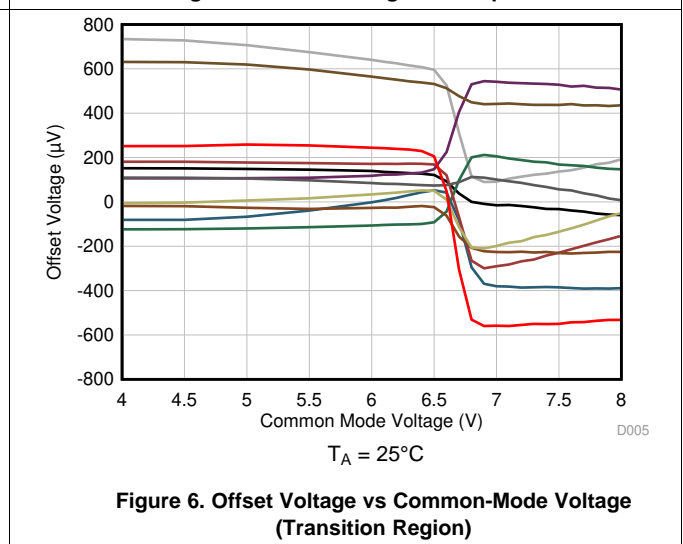
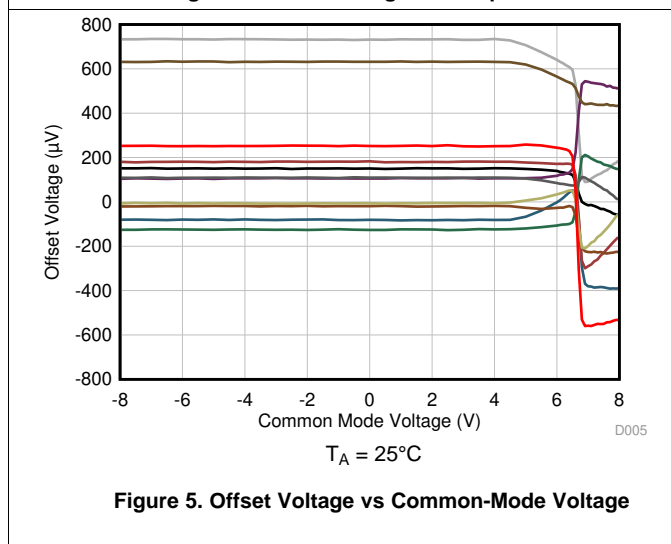
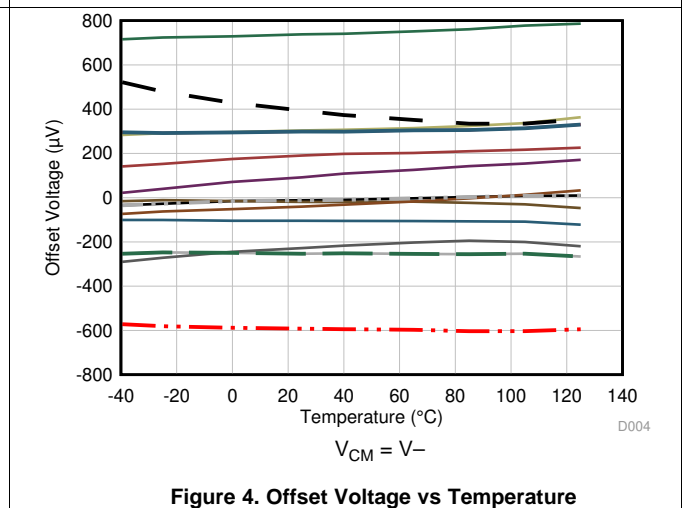
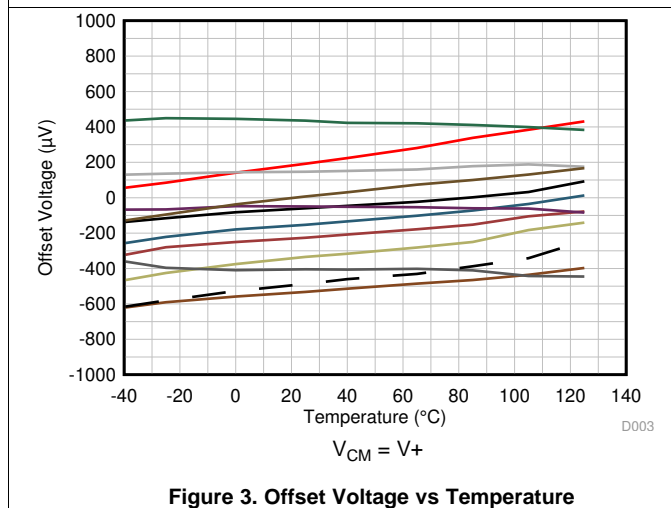
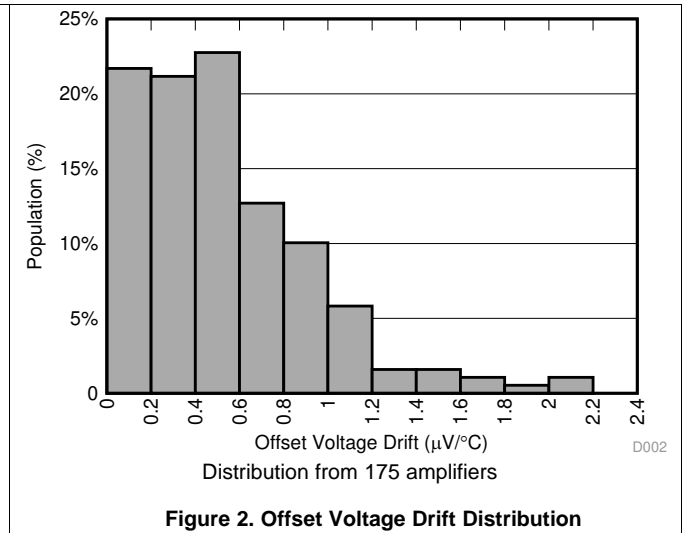
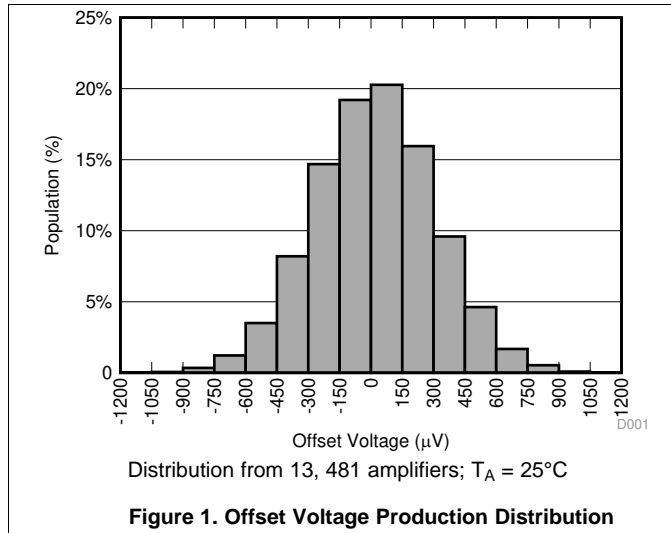
(1) Disable time (t_{OFF}) and enable time (t_{ON}) are defined as the time interval between the 50% point of the signal applied to the $\overline{\text{SHDN}}$ pin and the point at which the output voltage reaches the 10% (disable) or 90% (enable) level.

Table 1. Table of Graphs

| DESCRIPTION | FIGURE |
|--|---|
| Offset Voltage Production Distribution | Figure 1 |
| Offset Voltage Drift Distribution | Figure 2 |
| Offset Voltage vs Temperature | Figure 3 , Figure 4 |
| Offset Voltage vs Common-Mode Voltage | Figure 6 , Figure 7 , Figure 8 |
| Offset Voltage vs Power Supply | Figure 9 |
| Open-Loop Gain and Phase vs Frequency | Figure 10 |
| Closed-Loop Gain and Phase vs Frequency | Figure 11 |
| Input Bias Current vs Common-Mode Voltage | Figure 12 |
| Input Bias Current vs Temperature | Figure 13 |
| Output Voltage Swing vs Output Current | Figure 14 , Figure 15 , Figure 16 , Figure 17 |
| CMRR and PSRR vs Frequency | Figure 18 |
| CMRR vs Temperature | Figure 19 |
| PSRR vs Temperature | Figure 20 |
| 0.1-Hz to 10-Hz Noise | Figure 21 |
| Input Voltage Noise Spectral Density vs Frequency | Figure 22 |
| THD+N Ratio vs Frequency | Figure 23 |
| THD+N vs Output Amplitude | Figure 24 |
| Quiescent Current vs Supply Voltage | Figure 25 |
| Quiescent Current vs Temperature | Figure 26 |
| Open Loop Voltage Gain vs Temperature | Figure 27 |
| Open Loop Output Impedance vs Frequency | Figure 28 |
| Small Signal Overshoot vs Capacitive Load (100-mV Output Step) | Figure 29 , Figure 30 |
| Phase Margin vs Capacitive Load | Figure 31 |
| No Phase Reversal | Figure 32 |
| Positive Overload Recovery | Figure 33 |
| Negative Overload Recovery | Figure 34 |
| Small-Signal Step Response (100 mV) | Figure 35 , Figure 36 |
| Large-Signal Step Response | Figure 37 , Figure 38 , Figure 39 |
| Short-Circuit Current vs Temperature | Figure 40 |
| Maximum Output Voltage vs Frequency | Figure 41 |
| Channel Separation vs Frequency | Figure 42 |
| EMIRR vs Frequency | Figure 43 |

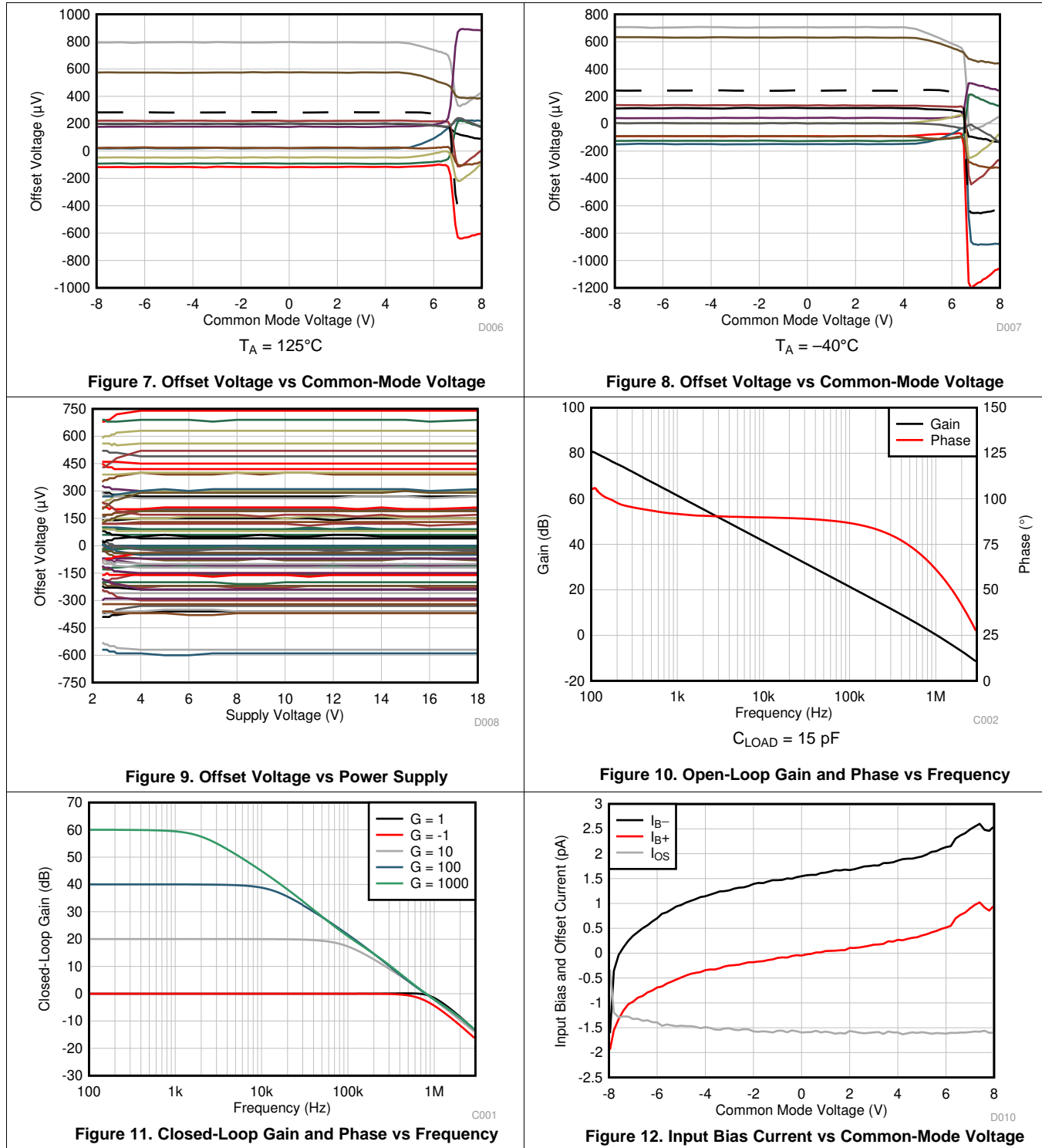
6.8 Typical Characteristics

at $T_A = 25^\circ\text{C}$, $V_S = \pm 8\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$ (unless otherwise noted)



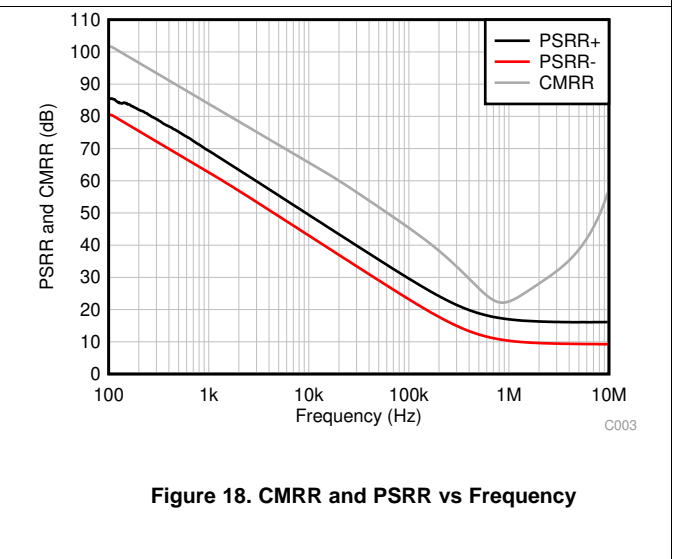
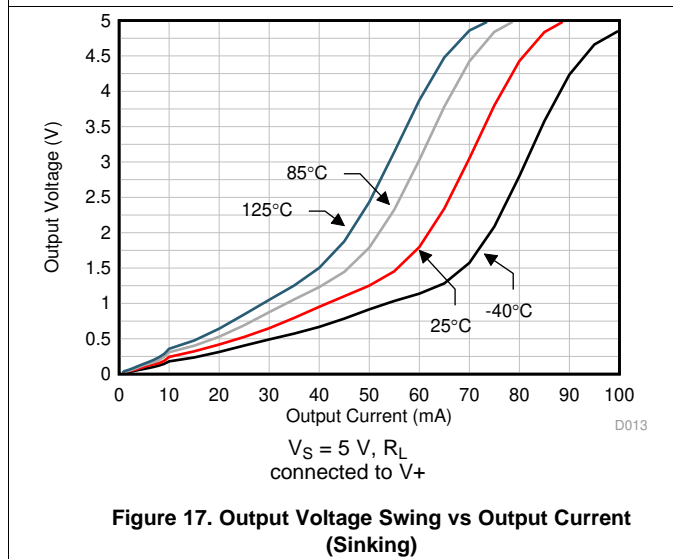
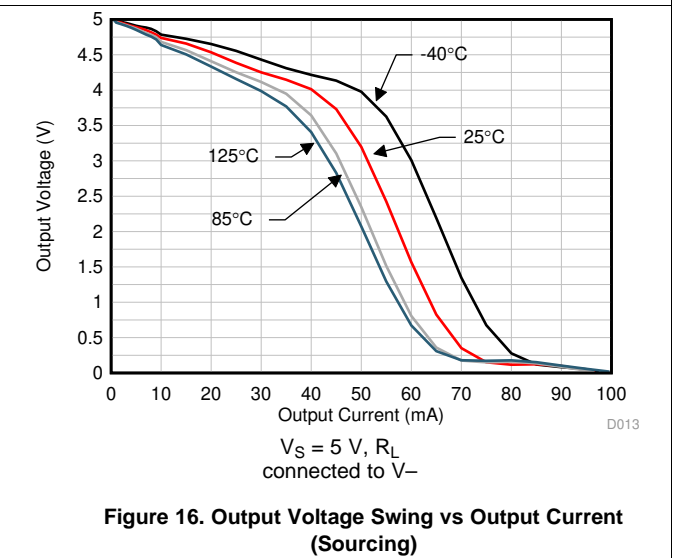
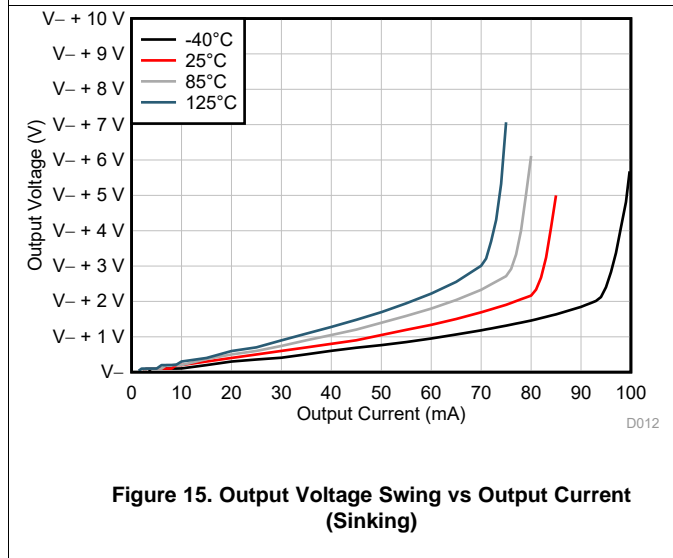
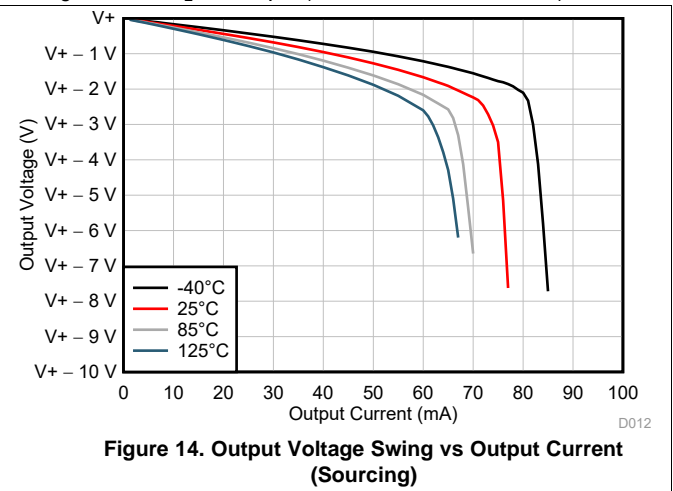
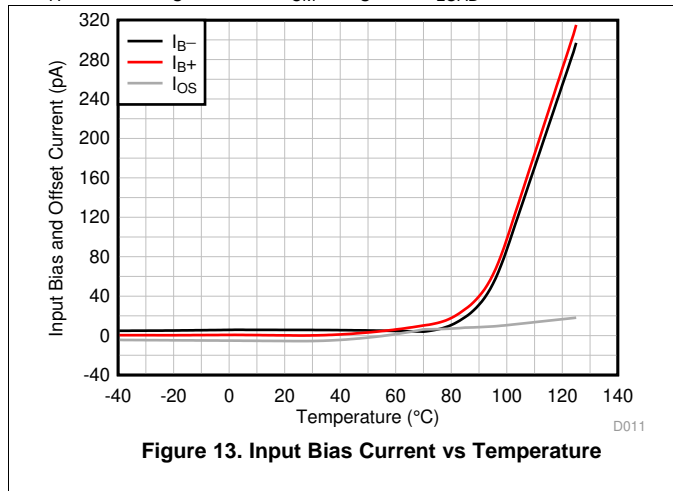
Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$, $V_S = \pm 8\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$ (unless otherwise noted)



Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$, $V_S = \pm 8\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$ (unless otherwise noted)



Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$, $V_S = \pm 8\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$ (unless otherwise noted)

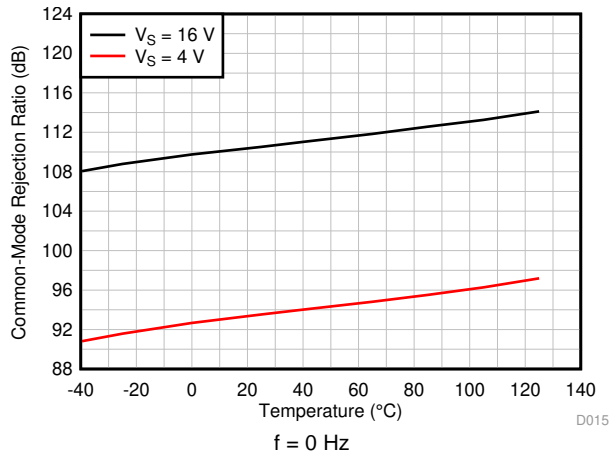


Figure 19. CMRR vs Temperature (dB)

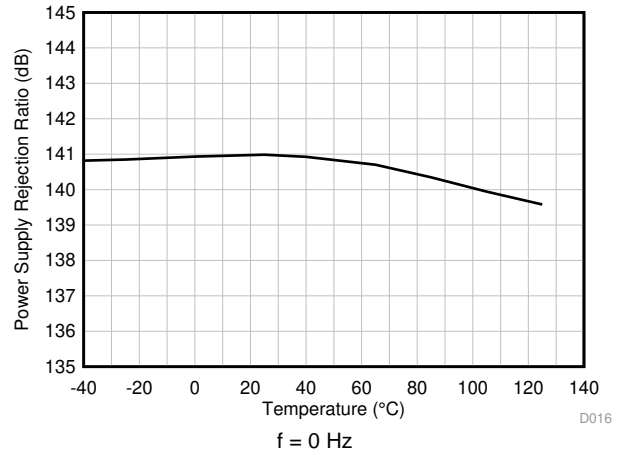


Figure 20. PSRR vs Temperature (dB)

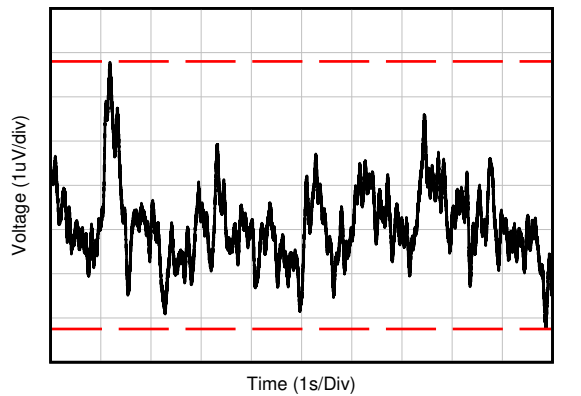


Figure 21. 0.1-Hz to 10-Hz Noise

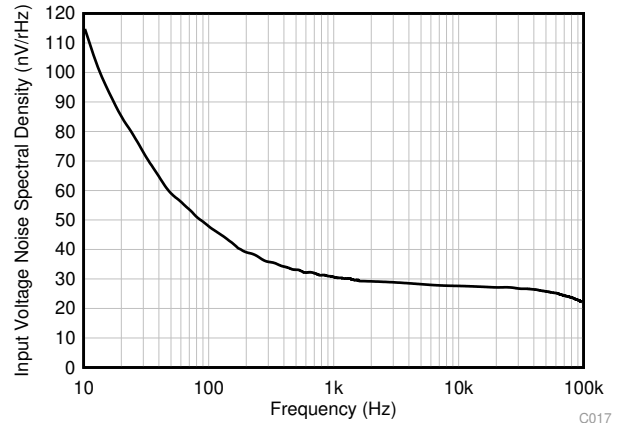


Figure 22. Input Voltage Noise Spectral Density vs Frequency

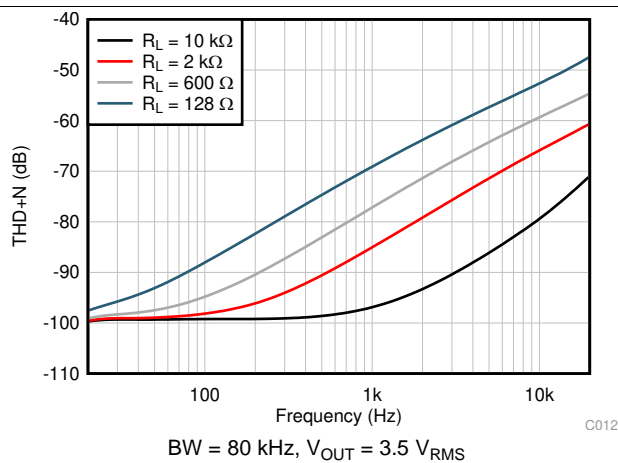


Figure 23. THD+N Ratio vs Frequency

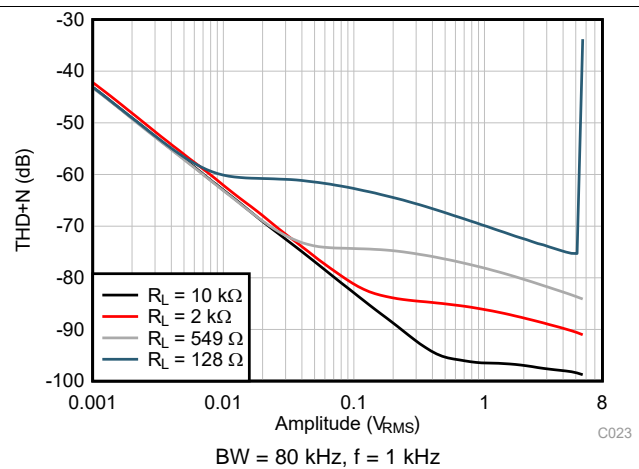
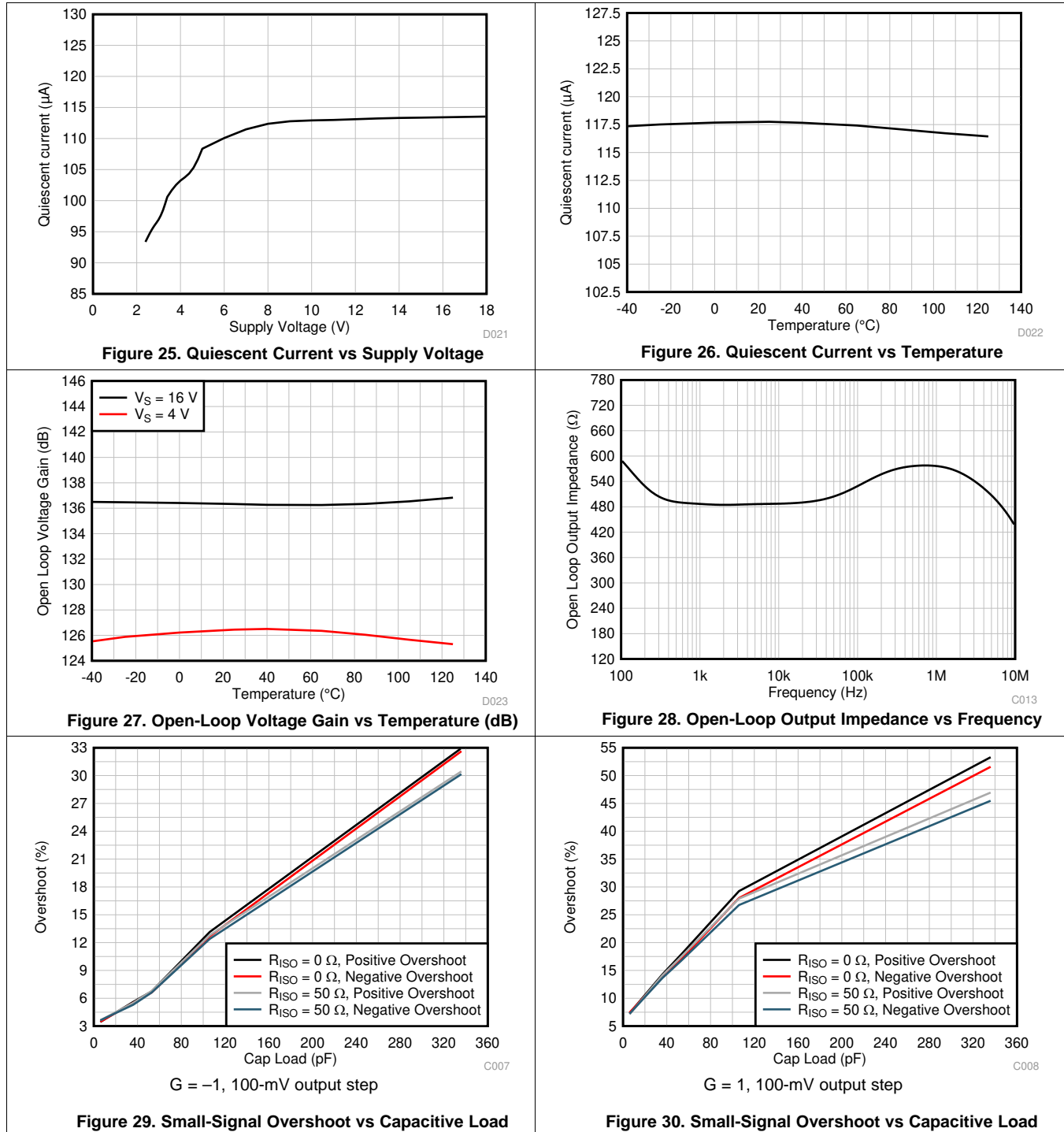


Figure 24. THD+N vs Output Amplitude

Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$, $V_S = \pm 8\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$ (unless otherwise noted)



Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$, $V_S = \pm 8\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$ (unless otherwise noted)

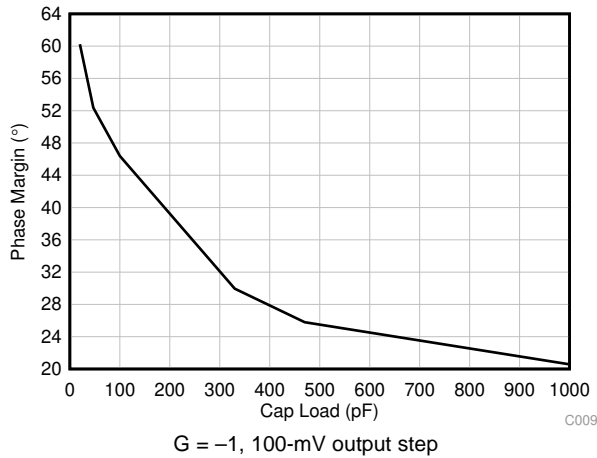


Figure 31. Small-Signal Overshoot vs Capacitive Load

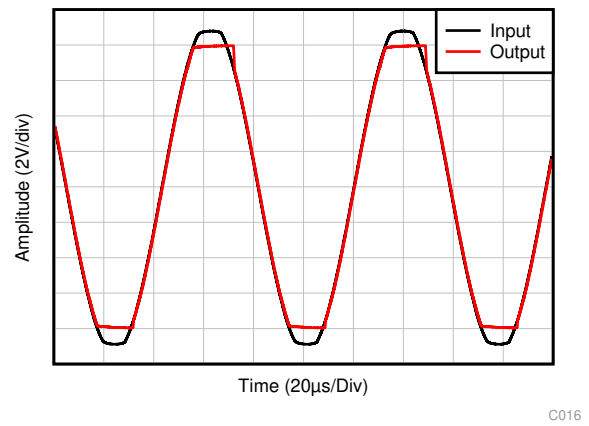


Figure 32. No Phase Reversal

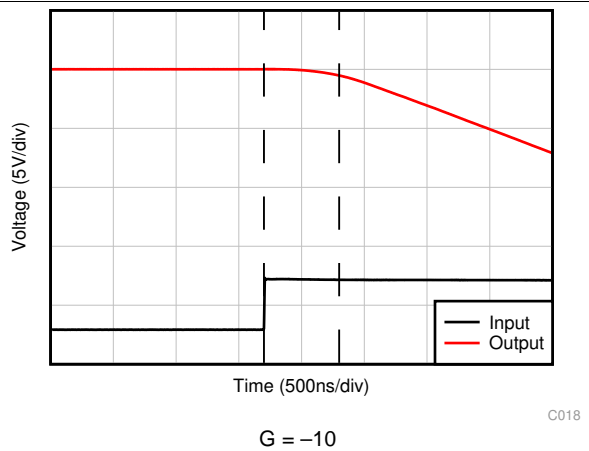


Figure 33. Positive Overload Recovery

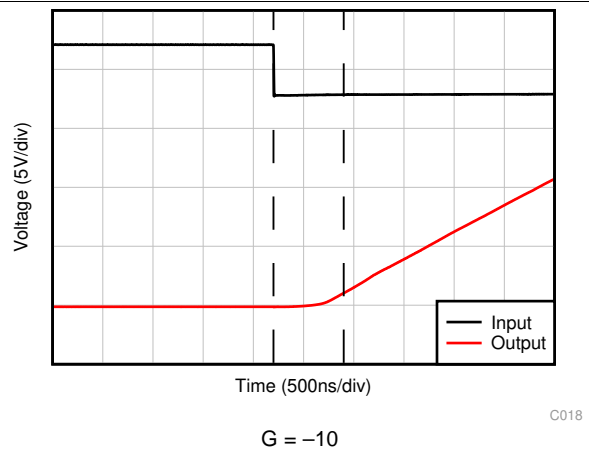


Figure 34. Negative Overload Recovery

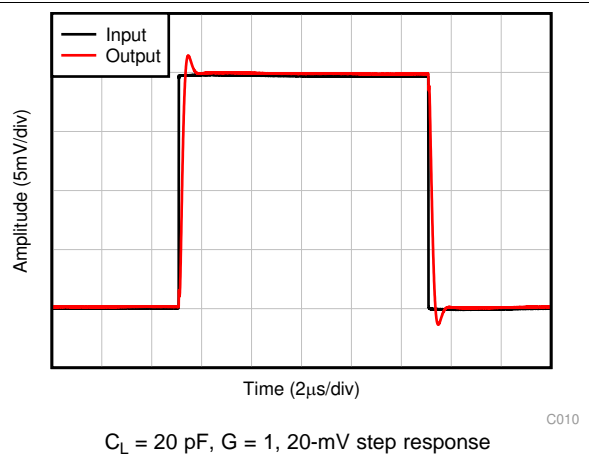


Figure 35. Small-Signal Step Response

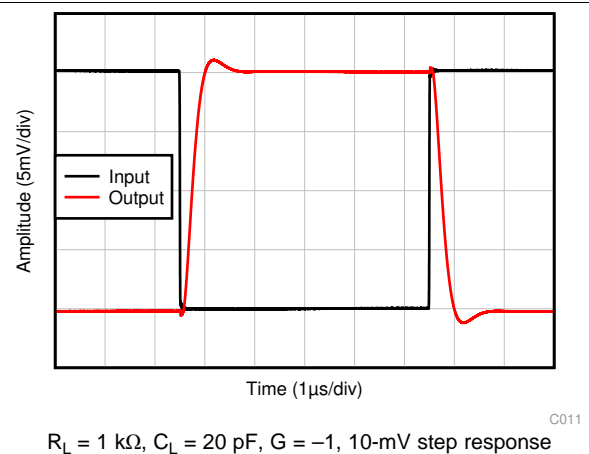
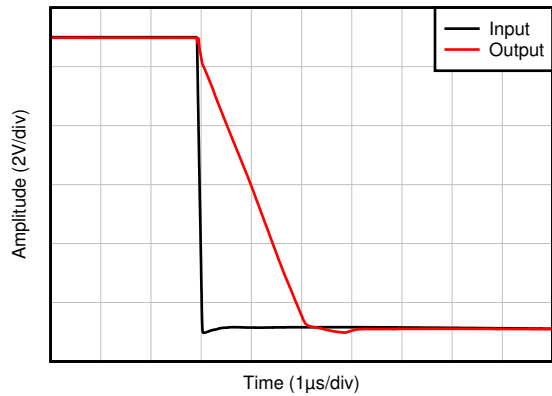


Figure 36. Small-Signal Step Response

Typical Characteristics (continued)

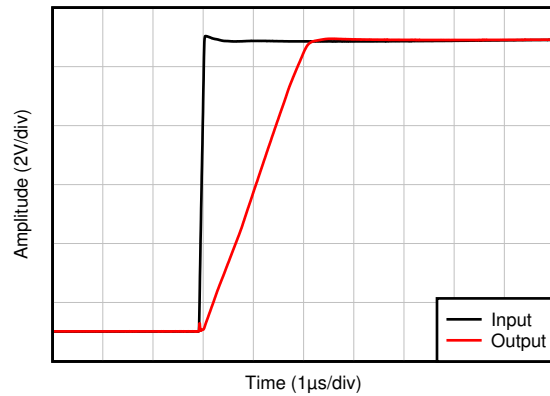
at $T_A = 25^\circ\text{C}$, $V_S = \pm 8\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$ (unless otherwise noted)



$C_L = 20\text{ pF}$, $G = 1$

C005

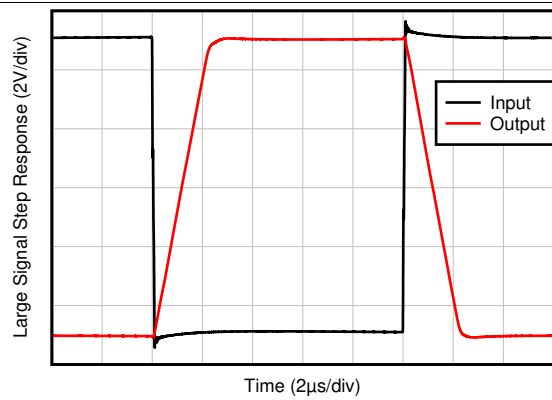
Figure 37. Large-Signal Step Response (Falling)



$C_L = 20\text{ pF}$, $G = 1$

C005

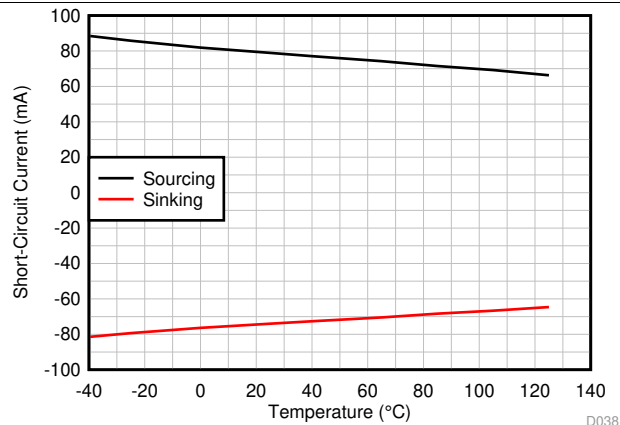
Figure 38. Large-Signal Step Response (Rising)



$C_L = 10\text{ pF}$, $G = -1$

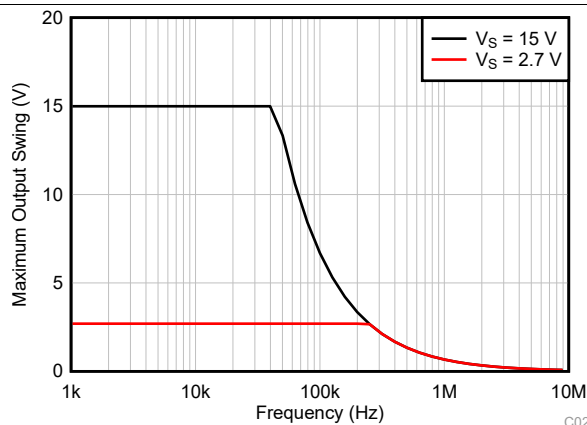
C021

Figure 39. Large-Signal Step Response



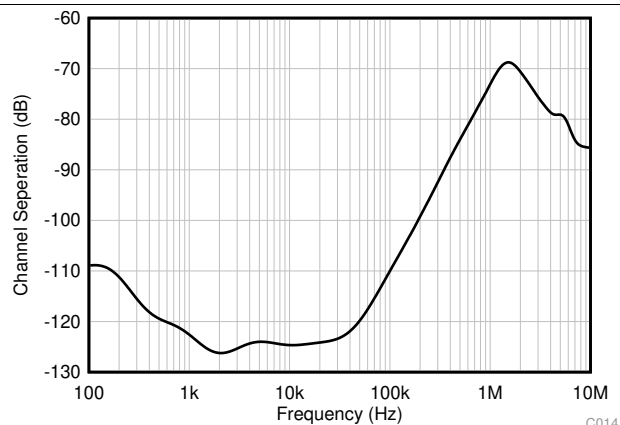
D038

Figure 40. Short-Circuit Current vs Temperature



C020

Figure 41. Maximum Output Voltage vs Frequency



C014

Figure 42. Channel Separation vs Frequency

Typical Characteristics (continued)

at $T_A = 25^\circ\text{C}$, $V_S = \pm 8\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$ (unless otherwise noted)

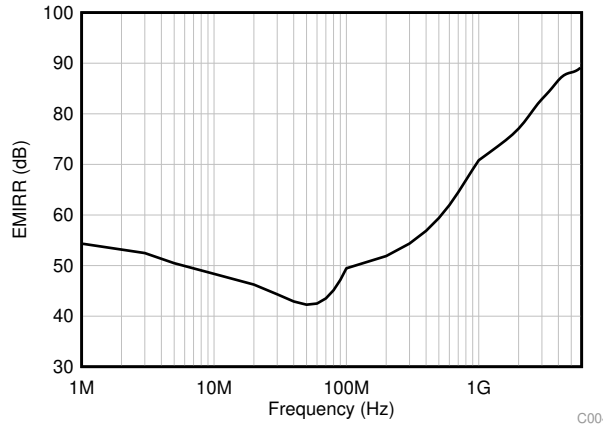


Figure 43. EMIRR (Electromagnetic Interference Rejection Ratio) vs Frequency

7 Detailed Description

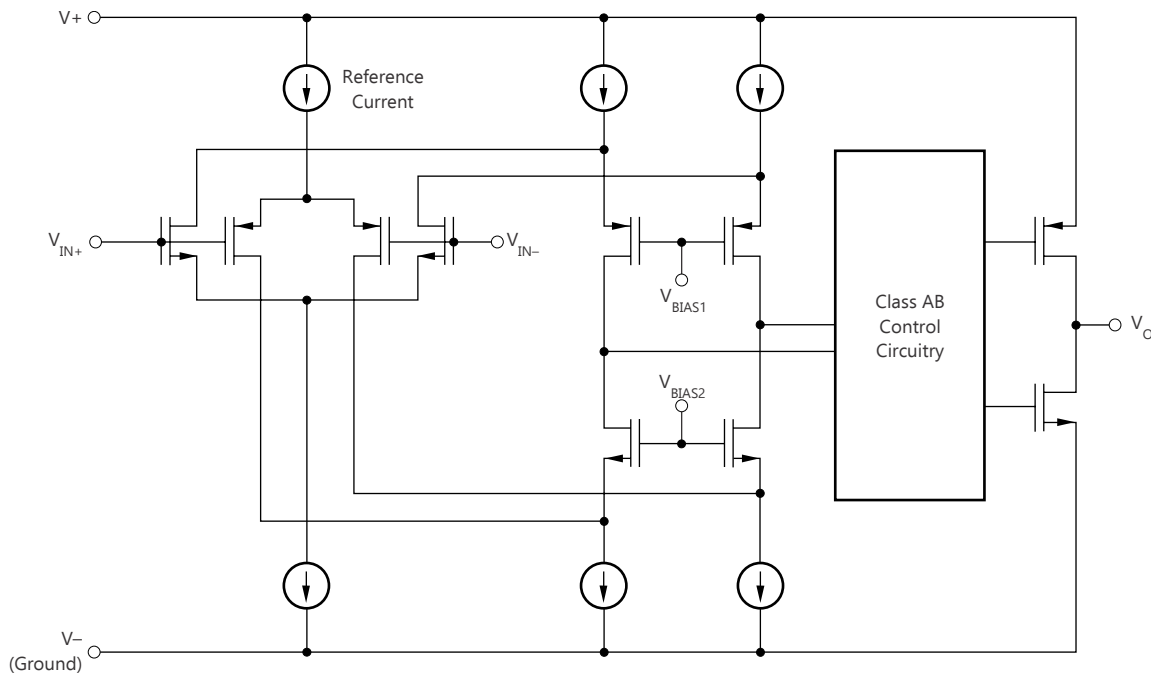
7.1 Overview

The TLV910x family (TLV9101, TLV9102, and TLV9104) is a family of 16-V general purpose operational amplifiers.

These devices offer excellent DC precision and AC performance, including rail-to-rail input/output, low offset ($\pm 300 \mu\text{V}$, typ), low offset drift ($\pm 0.6 \mu\text{V}/^\circ\text{C}$, typ), and 1.1-MHz bandwidth.

Wide differential and common-mode input-voltage range, high output current ($\pm 80 \text{ mA}$), high slew rate ($4.5 \text{ V}/\mu\text{s}$), low power operation ($120 \mu\text{A}$, typ), and shutdown functionality make the TLV910x a robust, low-power, high-performance operational amplifier for industrial applications.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 EMI Rejection

The TLV910x uses integrated electromagnetic interference (EMI) filtering to reduce the effects of EMI from sources such as wireless communications and densely-populated boards with a mix of analog signal chain and digital components. EMI immunity can be improved with circuit design techniques; the TLV910x benefits from these design improvements. Texas Instruments has developed the ability to accurately measure and quantify the immunity of an operational amplifier over a broad frequency spectrum extending from 10 MHz to 6 GHz. Figure 44 shows the results of this testing on the TLV910x. Table 2 shows the EMIRR IN+ values for the TLV910x at particular frequencies commonly encountered in real-world applications. Table 2 lists applications that can be centered on or operated near the particular frequency shown. The *EMI Rejection Ratio of Operational Amplifiers* application report contains detailed information on the topic of EMIRR performance as it relates to op amps and is available for download from www.ti.com.

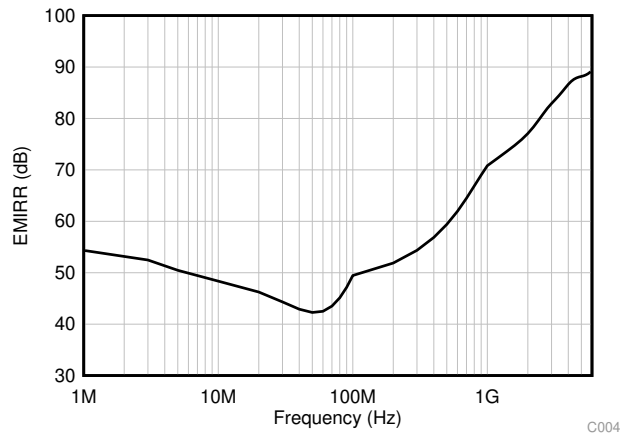


Figure 44. TLV910x EMIRR Testing

Table 2. TLV910x EMIRR IN+ for Frequencies of Interest

| FREQUENCY | APPLICATION OR ALLOCATION | EMIRR IN+ |
|-----------|--|-----------|
| 400 MHz | Mobile radio, mobile satellite, space operation, weather, radar, ultra-high frequency (UHF) applications | 59.5 dB |
| 900 MHz | Global system for mobile communications (GSM) applications, radio communication, navigation, GPS (to 1.6 GHz), GSM, aeronautical mobile, UHF applications | 68.9 dB |
| 1.8 GHz | GSM applications, mobile personal communications, broadband, satellite, L-band (1 GHz to 2 GHz) | 77.8 dB |
| 2.4 GHz | 802.11b, 802.11g, 802.11n, Bluetooth®, mobile personal communications, industrial, scientific and medical (ISM) radio band, amateur radio and satellite, S-band (2 GHz to 4 GHz) | 78.0 dB |
| 3.6 GHz | Radiolocation, aero communication and navigation, satellite, mobile, S-band | 88.8 dB |
| 5 GHz | 802.11a, 802.11n, aero communication and navigation, mobile communication, space and satellite operation, C-band (4 GHz to 8 GHz) | 87.6 dB |

7.3.2 Phase Reversal Protection

The TLV910x family has internal phase-reversal protection. Many op amps exhibit a phase reversal when the input is driven beyond its linear common-mode range. This condition is most often encountered in noninverting circuits when the input is driven beyond the specified common-mode voltage range, causing the output to reverse into the opposite rail. The TLV910x is a rail-to-rail input op amp; therefore, the common-mode range can extend up to the rails. Input signals beyond the rails do not cause phase reversal; instead, the output limits into the appropriate rail. This performance is shown in Figure 45.

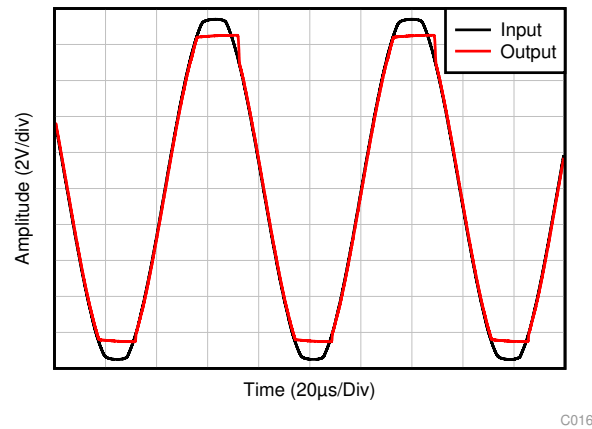


Figure 45. No Phase Reversal

7.3.3 Thermal Protection

The internal power dissipation of any amplifier causes its internal (junction) temperature to rise. This phenomenon is called *self heating*. The absolute maximum junction temperature of the TLV910x is 150°C. Exceeding this temperature causes damage to the device. The TLV910x has a thermal protection feature that prevents damage from self heating. The protection works by monitoring the temperature of the device and turning off the op amp output drive for temperatures above 140°C. Figure 46 shows an application example for the TLV9101 that has significant self heating (154°C) because of its power dissipation (0.39 W). Thermal calculations indicate that for an ambient temperature of 100°C, the device junction temperature must reach 154°C. The actual device, however, turns off the output drive to maintain a safe junction temperature. Figure 46 shows how the circuit behaves during thermal protection. During normal operation, the device acts as a buffer so the output is 3 V. When self heating causes the device junction temperature to increase above 140°C, the thermal protection forces the output to a high-impedance state and the output is pulled to ground through resistor RL.

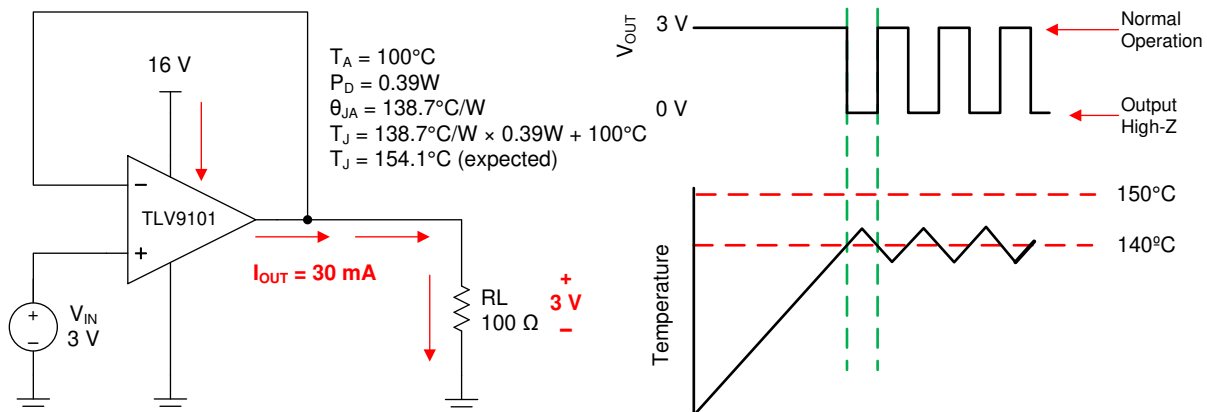
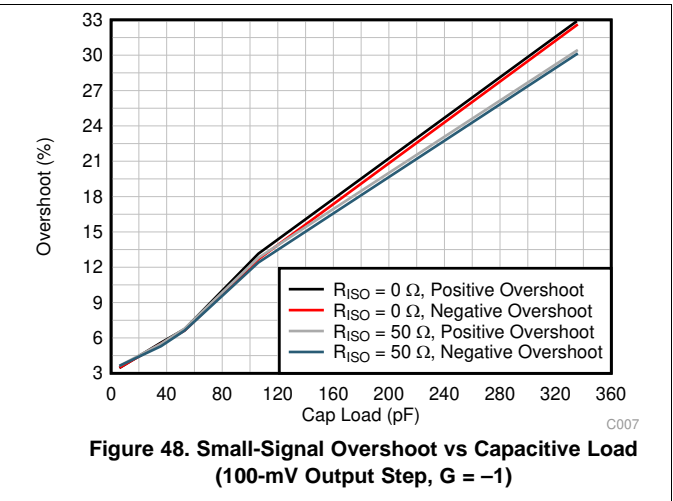
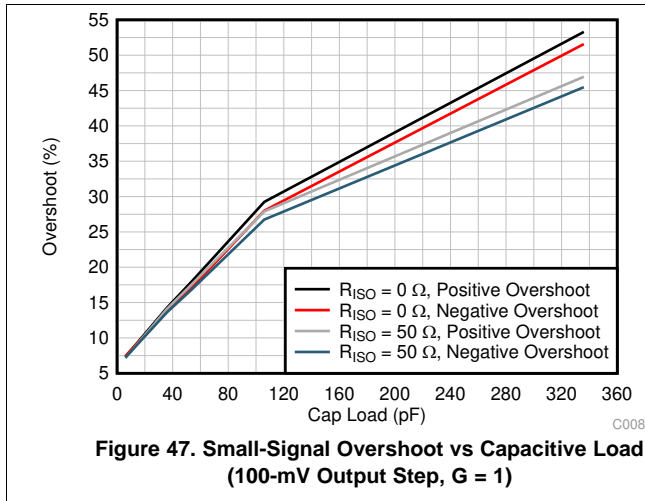


Figure 46. Thermal Protection

7.3.4 Capacitive Load and Stability

The TLV910x features a resistive output stage capable of driving moderate capacitive loads, and by leveraging an isolation resistor, the device can easily be configured to drive large capacitive loads. Increasing the gain enhances the ability of the amplifier to drive greater capacitive loads; see [Figure 47](#) and [Figure 48](#). The particular op amp circuit configuration, layout, gain, and output loading are some of the factors to consider when establishing whether an amplifier will be stable in operation.



For additional drive capability in unity-gain configurations, improve capacitive load drive by inserting a small (10 Ω to 20 Ω) resistor, R_{ISO} , in series with the output, as shown in [Figure 49](#). This resistor significantly reduces ringing and maintains DC performance for purely capacitive loads. However, if a resistive load is in parallel with the capacitive load, then a voltage divider is created, thus introducing a gain error at the output and slightly reducing the output swing. The error introduced is proportional to the ratio R_{ISO} / R_L , and is generally negligible at low output levels. A high capacitive load drive makes the TLV910x well suited for applications such as reference buffers, MOSFET gate drives, and cable-shield drives. The circuit shown in [Figure 49](#) uses an isolation resistor, R_{ISO} , to stabilize the output of an op amp. R_{ISO} modifies the open-loop gain of the system for increased phase margin.

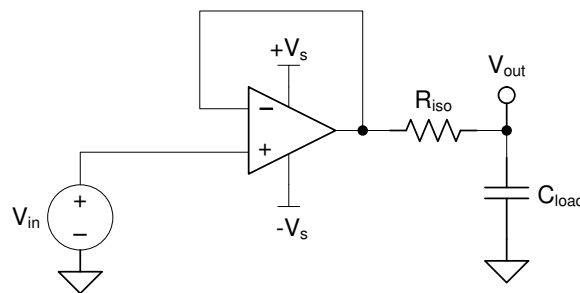


Figure 49. Extending Capacitive Load Drive With the TLV9101

7.3.5 Common-Mode Voltage Range

The TLV910x is a 16-V, true rail-to-rail input operational amplifier with an input common-mode range that extends 100 mV beyond either supply rail. This wide range is achieved with paralleled complementary N-channel and P-channel differential input pairs, as shown in [Figure 50](#). The N-channel pair is active for input voltages close to the positive rail, typically $(V+) - 1\text{ V}$ to 100 mV above the positive supply. The P-channel pair is active for inputs from 100 mV below the negative supply to approximately $(V+) - 2\text{ V}$. There is a small transition region, typically $(V+) - 2\text{ V}$ to $(V+) - 1\text{ V}$ in which both input pairs are on. This transition region can vary modestly with process variation, and within this region PSRR, CMRR, offset voltage, offset drift, noise, and THD performance can be degraded compared to operation outside this region. To achieve best performance with the TLV910x family, avoid this transition region when possible.

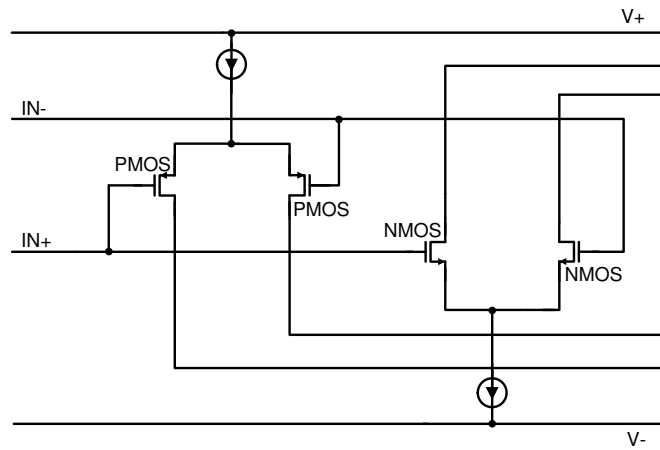


Figure 50. Rail-to-Rail Input Stage

7.3.6 Electrical Overstress

Designers often ask questions about the capability of an operational amplifier to withstand electrical overstress (EOS). These questions tend to focus on the device inputs, but can involve the supply voltage pins or even the output pin. Each of these different pin functions have electrical stress limits determined by the voltage breakdown characteristics of the particular semiconductor fabrication process and specific circuits connected to the pin. Additionally, internal electrostatic discharge (ESD) protection is built into these circuits to protect them from accidental ESD events both before and during product assembly.

Having a good understanding of this basic ESD circuitry and its relevance to an electrical overstress event is helpful. Figure 51 shows an illustration of the ESD circuits contained in the TLV910x (indicated by the dashed line area). The ESD protection circuitry involves several current-steering diodes connected from the input and output pins and routed back to the internal power-supply lines, where the diodes meet at an absorption device or the power-supply ESD cell, internal to the operational amplifier. This protection circuitry is intended to remain inactive during normal circuit operation.

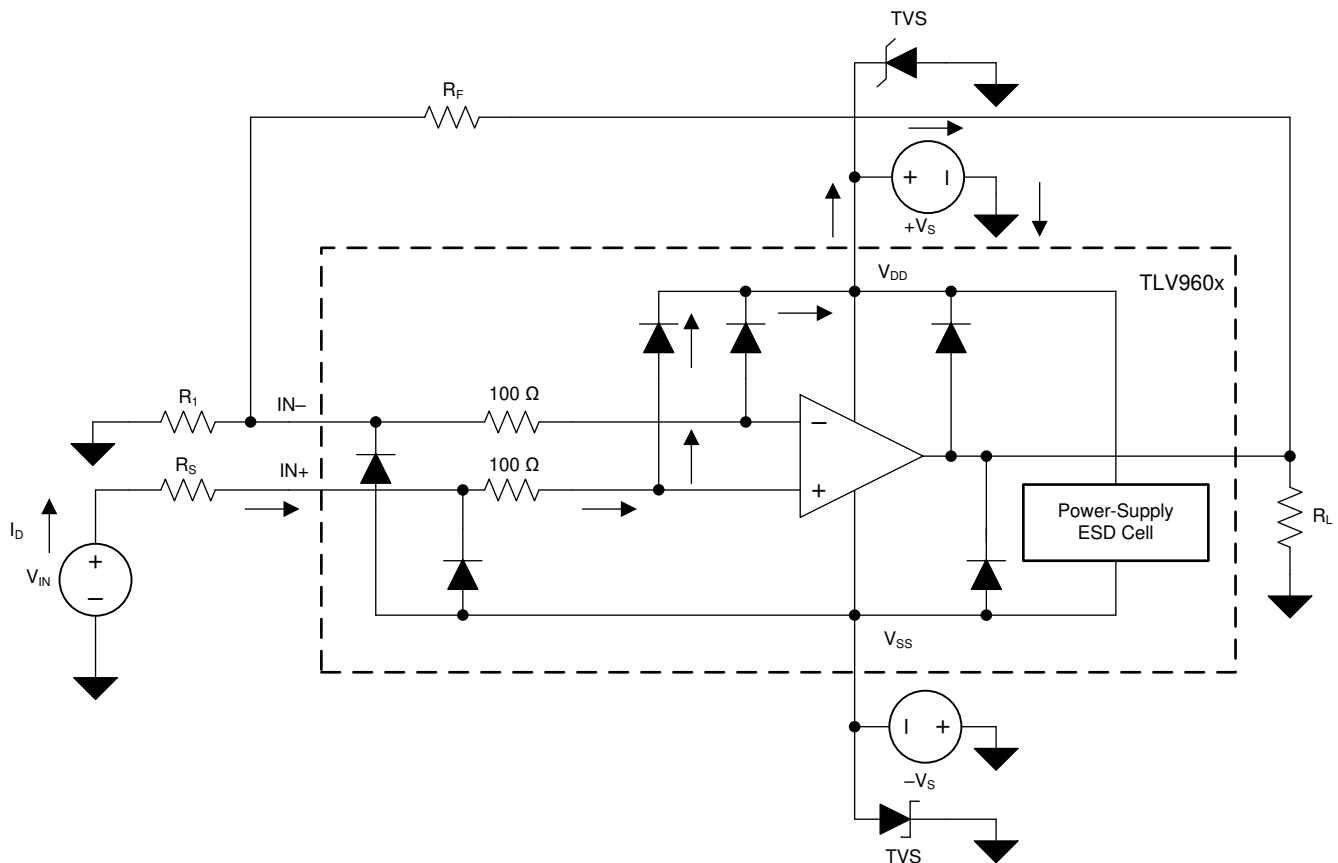


Figure 51. Equivalent Internal ESD Circuitry Relative to a Typical Circuit Application

An ESD event is very short in duration and very high voltage (for example, 1 kV, 100 ns), whereas an EOS event is long duration and lower voltage (for example, 50 V, 100 ms). The ESD diodes are designed for out-of-circuit ESD protection (that is, during assembly, test, and storage of the device before being soldered to the PCB). During an ESD event, the ESD signal is passed through the ESD steering diodes to an absorption circuit (labeled ESD power-supply circuit). The ESD absorption circuit clamps the supplies to a safe level.

Although this behavior is necessary for out-of-circuit protection, excessive current and damage is caused if activated in-circuit. A transient voltage suppressors (TVS) can be used to prevent damage caused by turning on the ESD absorption circuit during an in-circuit ESD event. Using the appropriate current limiting resistors and TVS diodes allows for the use of device ESD diodes to protect against EOS events.

7.3.7 Overload Recovery

Overload recovery is defined as the time required for the op amp output to recover from a saturated state to a linear state. The output devices of the op amp enter a saturation region when the output voltage exceeds the rated operating voltage, either due to the high input voltage or the high gain. After the device enters the saturation region, the charge carriers in the output devices require time to return back to the linear state. After the charge carriers return back to the linear state, the device begins to slew at the specified slew rate. Thus, the propagation delay in case of an overload condition is the sum of the overload recovery time and the slew time. The overload recovery time for the TLV910x is approximately 1 μ s.

7.3.8 Typical Specifications and Distributions

Designers often have questions about a typical specification of an amplifier in order to design a more robust circuit. Due to natural variation in process technology and manufacturing procedures, every specification of an amplifier will exhibit some amount of deviation from the ideal value, like the input offset voltage of an amplifier. These deviations often follow *Gaussian* ("bell curve"), or *normal* distributions, and circuit designers can leverage this information to guardband their system, even when there is not a minimum or maximum specification in the [Electrical Characteristics](#) table.

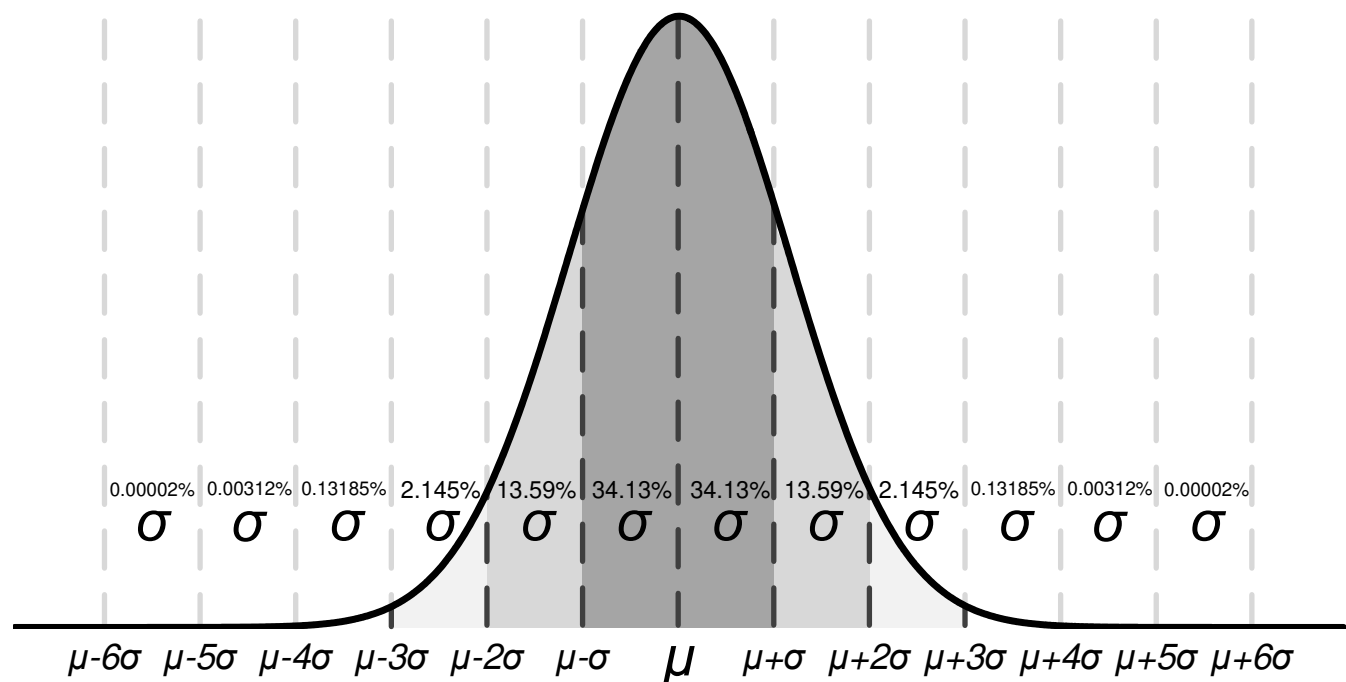


Figure 52. Ideal Gaussian Distribution

Figure 52 shows an example distribution, where μ , or *mu*, is the mean of the distribution, and where σ , or *sigma*, is the standard deviation of a system. For a specification that exhibits this kind of distribution, approximately two-thirds (68.26%) of all units can be expected to have a value within one standard deviation, or one sigma, of the mean (from $\mu - \sigma$ to $\mu + \sigma$).

Depending on the specification, values listed in the *typical* column of the [Electrical Characteristics](#) table are represented in different ways. As a general rule of thumb, if a specification naturally has a nonzero mean (for example, gain bandwidth), then the typical value is equal to the mean (μ). However, if a specification naturally has a mean near zero (like input offset voltage), then the typical value is equal to the mean plus one standard deviation ($\mu + \sigma$) in order to most accurately represent the typical value.

You can use this chart to calculate approximate probability of a specification in a unit; for example, for TLV910x, the typical input voltage offset is 300 μ V, so 68.2% of all TLV910x devices are expected to have an offset from -300μ V to $+300 \mu$ V. At 4σ ($\pm 1200 \mu$ V), 99.9937% of the distribution has an offset voltage less than $\pm 1200 \mu$ V, which means 0.0063% of the population is outside of these limits, which corresponds to about 1 in 15,873 units.

Specifications with a value in the minimum or maximum column are assured by TI, and units outside these limits will be removed from production material. For example, the TLV910x family has a maximum offset voltage of 1.5 mV at 25°C, and even though this corresponds to 5σ (≈ 1 in 1.7 million units), which is extremely unlikely, TI assures that any unit with larger offset than 1.5 mV will be removed from production material.

For specifications with no value in the minimum or maximum column, consider selecting a sigma value of sufficient guardband for your application, and design worst-case conditions using this value. For example, the $6\text{-}\sigma$ value corresponds to about 1 in 500 million units, which is an extremely unlikely chance and can be an option as a wide guardband to design a system around. In this case, the TLV910x family does not have a maximum or minimum for offset voltage drift, but based on [Figure 2](#) and the typical value of 0.6 μ V/°C in the [Electrical Characteristics](#) table, it can be calculated that the $6\text{-}\sigma$ value for offset voltage drift is about 3.6 μ V/°C. When designing for worst-case system conditions, this value can be used to estimate the worst possible offset across temperature without having an actual minimum or maximum value.

However, process variation and adjustments over time can shift typical means and standard deviations, and unless there is a value in the minimum or maximum specification column, TI cannot assure the performance of a device. This information should be used only to estimate the performance of a device.

7.3.9 Packages With an Exposed Thermal Pad

The TLV910x family is available in packages such as the WSON-8 (DSG) and WQFN-16 (RTE), which feature an exposed thermal pad. Inside the package, the die is attached to this thermal pad using an electrically conductive compound. For this reason, when using a package with an exposed thermal pad, the thermal pad must either be connected to V $-$ or left floating. Attaching the thermal pad to a potential other than V $-$ is not allowed, and performance of the device is not assured when doing so.

7.3.10 Shutdown

The TLV910xS devices feature one or more shutdown pins (SHDN) that disable the op amp, placing it into a low-power standby mode. In this mode, the op amp typically consumes about 20 μ A. The SHDN pins are active high, meaning that shutdown mode is enabled when the input to the SHDN pin is a valid logic high.

The SHDN pins are referenced to the negative supply rail of the op amp. The threshold of the shutdown feature lies around 800 mV (typical) and does not change with respect to the supply voltage. Hysteresis has been included in the switching threshold to ensure smooth switching characteristics. To ensure optimal shutdown behavior, the SHDN pins should be driven with valid logic signals. A valid logic low is defined as a voltage between V $-$ and V $-$ + 0.4 V. A valid logic high is defined as a voltage between V $-$ + 1.2 V and V $+$. The shutdown pin circuitry includes a pulldown resistor, which will inherently pull the voltage of the pin to the negative supply rail if not driven. Thus, to enable the amplifier, the SHDN pins should either be left floating or driven to a valid logic low. To disable the amplifier, the SHDN pins must be driven to a valid logic high. The maximum voltage allowed at the SHDN pins is V $+$. Exceeding this voltage level will damage the device.

The SHDN pins are high-impedance CMOS inputs. Channels of single and dual op amp packages are independently controlled, and channels of quad op amp packages are controlled in pairs. For battery-operated applications, this feature can be used to greatly reduce the average current and extend battery life. The typical enable time out of shutdown is 30 μ s; disable time is 3 μ s. When disabled, the output assumes a high-impedance state. This architecture allows the TLV910xS family to operate as a gated amplifier, multiplexer, or programmable-gain amplifier. Shutdown time (t_{OFF}) depends on loading conditions and increases as load resistance increases. To ensure shutdown (disable) within a specific shutdown time, the specified 10-k Ω load to midsupply (VS / 2) is required. If using the TLV910xS without a load, the resulting turnoff time significantly increases.

7.4 Device Functional Modes

The TLV910x has a single functional mode and is operational when the power-supply voltage is greater than 2.7 V (± 1.35 V). The maximum power supply voltage for the TLV910x is 16 V (± 8 V).

8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The TLV910x family offers excellent DC precision and DC performance. These devices operate up to 16-V supply rails and offer true rail-to-rail input/output, low offset voltage and offset voltage drift, as well as 1.1-MHz bandwidth and high output drive. These features make the TLV910x a robust, high-performance operational amplifier for high-voltage industrial applications.

8.2 Typical Applications

8.2.1 High Voltage Precision Comparator

Many different systems require controlled voltages across numerous system nodes to ensure robust operation. A comparator can be used to monitor and control voltages by comparing a reference threshold voltage with an input voltage and providing an output when the input crosses this threshold.

The TLV910x family of op amps make excellent high voltage, precision comparators due to their robust input stage, low typical offset, and high slew rate. Previous generation high-voltage op amps often use back-to-back diodes across the inputs to prevent damage to the op amp which greatly limits these op amps to be used as comparators, but the patented input stage of the TLV910x allows the device to have a wide differential voltage between the inputs.

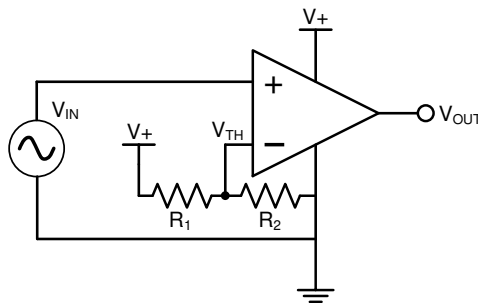


Figure 53. Typical Comparator Application

8.2.1.1 Design Requirements

The primary objective is to design a 15-V precision comparator.

- System supply voltage (V_+): 15 V
- Resistor 1 value: 100 k Ω
- Resistor 2 value: 100 k Ω
- Reference threshold voltage (V_{TH}): 7.5 V
- Input voltage range (V_{IN}): 2.5 V – 12.5 V
- Output voltage range (V_{OUT}): 0 V – 15 V

Typical Applications (continued)

8.2.1.2 Detailed Design Procedure

This noninverting comparator circuit applies the input voltage (V_{IN}) to the noninverting terminal of the op amp. Two resistors (R_1 and R_2) divide the supply voltage (V_+) to create a mid-supply threshold voltage (V_{TH}) as calculated in Equation 1. The circuit is shown in Figure 53. When V_{IN} is less than V_{TH} , the output voltage transitions to the negative supply and equals the low-level output voltage. When V_{IN} is greater than V_{TH} , the output voltage transitions to the positive supply and equals the high-level output voltage.

In this example, resistor 1 and 2 have been selected to be 100 k Ω , which sets the reference threshold at 7.5 V. However, resistor 1 and 2 can be adjusted to modify the threshold using Equation 1. The values of resistor 1 and 2 have also been selected to reduce power consumption, but these values can be further increased to reduce power consumption, or reduced to improve noise performance.

$$V_{TH} = \frac{R_2}{R_1 + R_2} \times V_+ \quad (1)$$

8.2.1.3 Application Curve

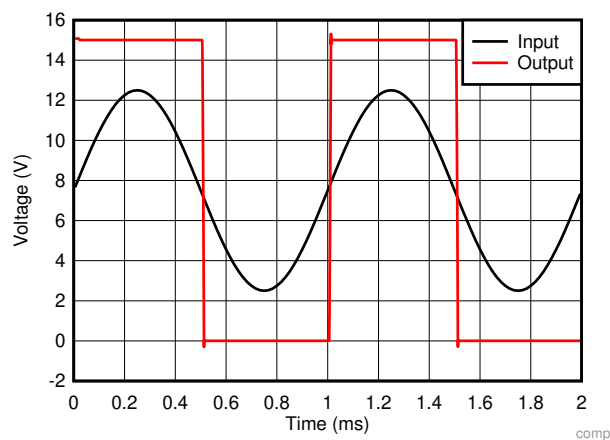


Figure 54. Comparator Output Response to Input Voltage

9 Power Supply Recommendations

The TLV910x is specified for operation from 2.7 V to 16 V (± 1.35 V to ± 8 V); many specifications apply from -40°C to 125°C .

CAUTION

Supply voltages larger than 20 V can permanently damage the device; see the [Absolute Maximum Ratings](#) table.

Place 0.1- μF bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or high-impedance power supplies. For more detailed information on bypass capacitor placement, refer to the [Layout](#) section.

10 Layout

10.1 Layout Guidelines

For best operational performance of the device, use good PCB layout practices, including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole and op amp itself. Bypass capacitors are used to reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
 - Connect low-ESR, 0.1- μF ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from $V+$ to ground is applicable for single-supply applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most-effective methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces EMI noise pickup. Make sure to physically separate digital and analog grounds paying attention to the flow of the ground current.
- In order to reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If these traces cannot be kept separate, crossing the sensitive trace perpendicular is much better as opposed to in parallel with the noisy trace.
- Place the external components as close to the device as possible. As illustrated in [Figure 56](#), keeping R_F and R_G close to the inverting input minimizes parasitic capacitance.
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.
- Cleaning the PCB following board assembly is recommended for best performance.
- Any precision integrated circuit may experience performance shifts due to moisture ingress into the plastic package. Following any aqueous PCB cleaning process, baking the PCB assembly is recommended to remove moisture introduced into the device packaging during the cleaning process. A low temperature, post cleaning bake at 85°C for 30 minutes is sufficient for most circumstances.

10.2 Layout Example

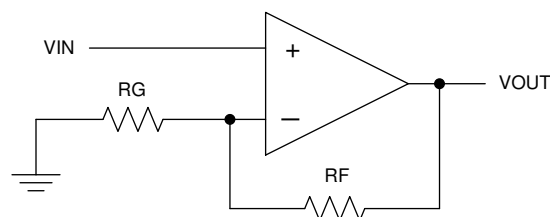


Figure 55. Schematic Representation

Layout Example (continued)

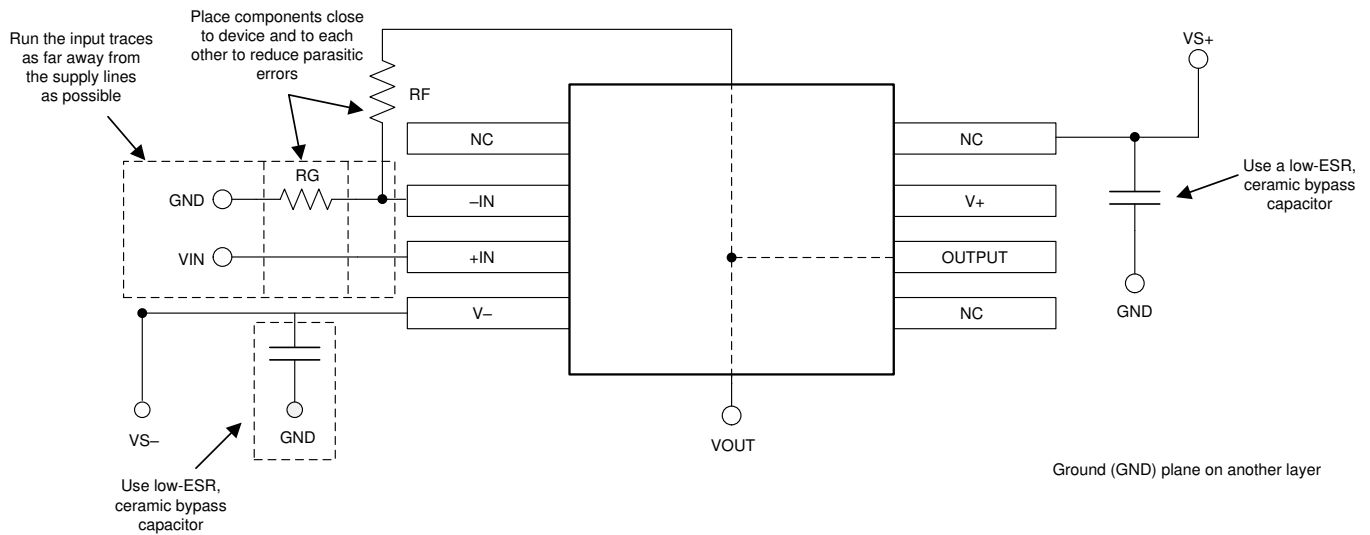


Figure 56. Operational Amplifier Board Layout for Noninverting Configuration

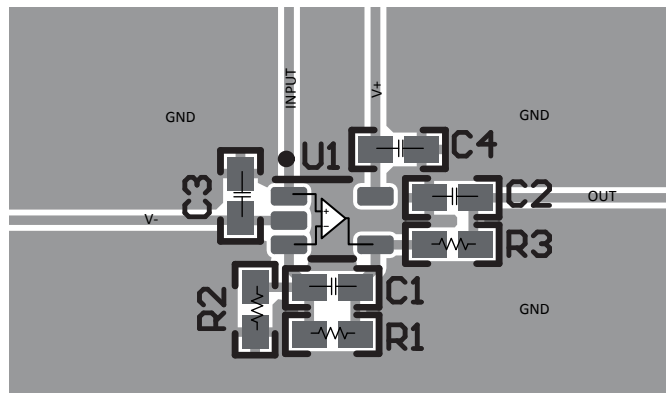


Figure 57. Example Layout for SC70 (DCK) Package

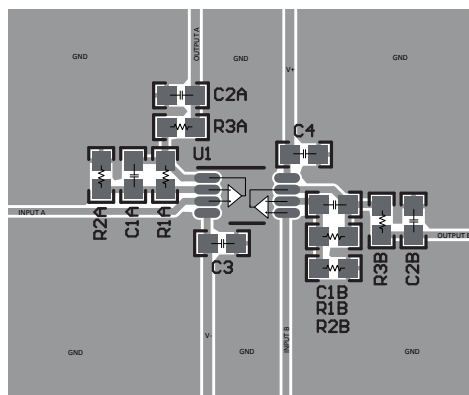


Figure 58. Example Layout for VSSOP-8 (DGK) Package

Layout Example (continued)

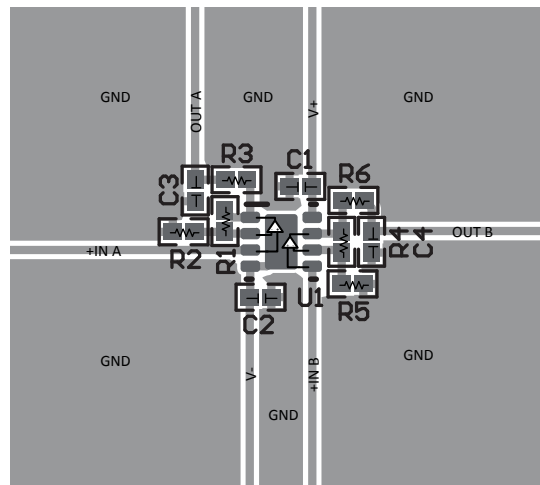


Figure 59. Example Layout for WSON-8 (DSG) Package

11 Device and Documentation Support

11.1 Device Support

11.1.1 Development Support

11.1.1.1 TINA-TI™ (Free Software Download)

TINA™ is a simple, powerful, and easy-to-use circuit simulation program based on a SPICE engine. TINA-TI is a free, fully-functional version of the TINA software, preloaded with a library of macro models in addition to a range of both passive and active models. TINA-TI provides all the conventional DC, transient, and frequency domain analysis of SPICE, as well as additional design capabilities.

Available as a [free download](#) from the Analog eLab Design Center, TINA-TI offers extensive post-processing capability that allows users to format results in a variety of ways. Virtual instruments offer the ability to select input waveforms and probe circuit nodes, voltages, and waveforms, creating a dynamic quick-start tool.

NOTE

These files require that either the TINA software (from DesignSoft™) or TINA-TI software be installed. Download the free TINA-TI software from the [TINA-TI folder](#).

11.2 Documentation Support

11.2.1 Related Documentation

Texas Instruments, [EMI Rejection Ratio of Operational Amplifiers application report](#)

11.3 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to order now.

Table 3. Related Links

| PARTS | PRODUCT FOLDER | ORDER NOW | TECHNICAL DOCUMENTS | TOOLS & SOFTWARE | SUPPORT & COMMUNITY |
|---------|----------------------------|----------------------------|----------------------------|----------------------------|----------------------------|
| TLV9101 | Click here | Click here | Click here | Click here | Click here |
| TLV9102 | Click here | Click here | Click here | Click here | Click here |
| TLV9104 | Click here | Click here | Click here | Click here | Click here |

11.4 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.5 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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11.7 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.8 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material (6) | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|-----------------|------|-------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| TLV9101IDBVR | ACTIVE | SOT-23 | DBV | 5 | 3000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | T91V | Samples |
| TLV9101SIDBVR | ACTIVE | SOT-23 | DBV | 6 | 3000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | T91S | Samples |
| TLV9102IDDFR | ACTIVE | SOT-23-THIN | DDF | 8 | 3000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 125 | T91F | Samples |
| TLV9102IDR | ACTIVE | SOIC | D | 8 | 2500 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | T9102D | Samples |
| TLV9102IDSGR | ACTIVE | WSON | DSG | 8 | 3000 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | T912 | Samples |
| TLV9102IPWR | ACTIVE | TSSOP | PW | 8 | 2000 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | T9102P | Samples |
| TLV9102SIDGSR | ACTIVE | VSSOP | DGS | 10 | 2500 | RoHS & Green | NIPDAUAG | Level-2-260C-1 YEAR | -40 to 125 | T910 | Samples |
| TLV9102SIRUGR | ACTIVE | X2QFN | RUG | 10 | 3000 | RoHS & Green | NIPDAUAG | Level-2-260C-1 YEAR | -40 to 125 | HBF | Samples |
| TLV9104IDR | ACTIVE | SOIC | D | 14 | 2500 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | TLV9104D | Samples |
| TLV9104IPWR | ACTIVE | TSSOP | PW | 14 | 2000 | RoHS & Green | SN | Level-2-260C-1 YEAR | -40 to 125 | (PTL91PW, TLV91PW) | Samples |
| TLV9104IRUCR | ACTIVE | QFN | RUC | 14 | 3000 | RoHS & Green | NIPDAU | Level-2-260C-1 YEAR | -40 to 125 | FOF | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION



QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|---------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| TLV9101IDBVR | SOT-23 | DBV | 5 | 3000 | 180.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q3 |
| TLV9101SIDBVR | SOT-23 | DBV | 6 | 3000 | 180.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q3 |
| TLV9102IDDFR | SOT-23-THIN | DDF | 8 | 3000 | 180.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q3 |
| TLV9102IDR | SOIC | D | 8 | 2500 | 330.0 | 12.4 | 6.4 | 5.2 | 2.1 | 8.0 | 12.0 | Q1 |
| TLV9102IDSGR | WSON | DSG | 8 | 3000 | 180.0 | 8.4 | 2.3 | 2.3 | 1.15 | 4.0 | 8.0 | Q2 |
| TLV9102IPWR | TSSOP | PW | 8 | 2000 | 330.0 | 12.4 | 7.0 | 3.6 | 1.6 | 8.0 | 12.0 | Q1 |
| TLV9102SIDGSR | VSSOP | DGS | 10 | 2500 | 330.0 | 12.4 | 5.3 | 3.4 | 1.4 | 8.0 | 12.0 | Q1 |
| TLV9102SIRUGR | X2QFN | RUG | 10 | 3000 | 178.0 | 8.4 | 1.75 | 2.25 | 0.56 | 4.0 | 8.0 | Q1 |
| TLV9104IDR | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| TLV9104IPWR | TSSOP | PW | 14 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |
| TLV9104IRUCR | QFN | RUC | 14 | 3000 | 180.0 | 9.5 | 2.16 | 2.16 | 0.5 | 4.0 | 8.0 | Q2 |

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|---------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TLV9101IDBVR | SOT-23 | DBV | 5 | 3000 | 210.0 | 185.0 | 35.0 |
| TLV9101SIDBVR | SOT-23 | DBV | 6 | 3000 | 210.0 | 185.0 | 35.0 |
| TLV9102IDDFR | SOT-23-THIN | DDF | 8 | 3000 | 210.0 | 185.0 | 35.0 |
| TLV9102IDR | SOIC | D | 8 | 2500 | 853.0 | 449.0 | 35.0 |
| TLV9102IDSGR | WSON | DSG | 8 | 3000 | 210.0 | 185.0 | 35.0 |
| TLV9102IPWR | TSSOP | PW | 8 | 2000 | 853.0 | 449.0 | 35.0 |
| TLV9102SIDGSR | VSSOP | DGS | 10 | 2500 | 366.0 | 364.0 | 50.0 |
| TLV9102SIRUGR | X2QFN | RUG | 10 | 3000 | 205.0 | 200.0 | 33.0 |
| TLV9104IDR | SOIC | D | 14 | 2500 | 853.0 | 449.0 | 35.0 |
| TLV9104IPWR | TSSOP | PW | 14 | 2000 | 366.0 | 364.0 | 50.0 |
| TLV9104IRUCR | QFN | RUC | 14 | 3000 | 205.0 | 200.0 | 30.0 |

EXAMPLE BOARD LAYOUT

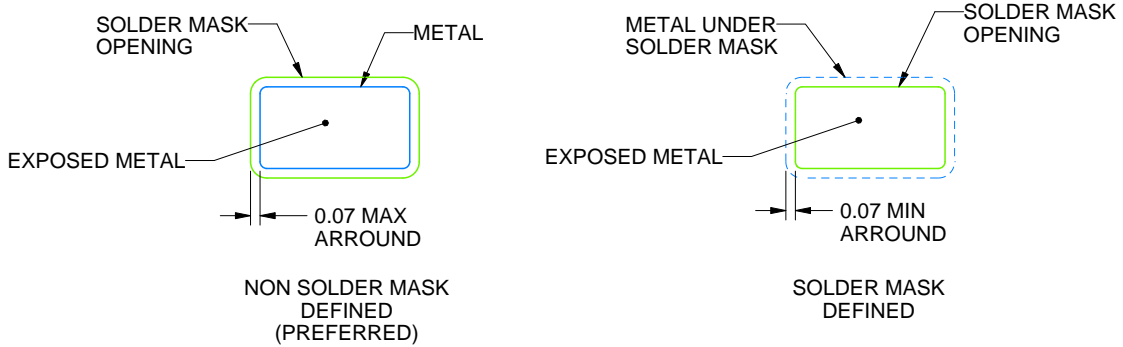
DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

4214839/E 09/2019

NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

4214839/E 09/2019

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

DGS0010A



PACKAGE OUTLINE

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



4221984/A 05/2015

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187, variation BA.

EXAMPLE BOARD LAYOUT

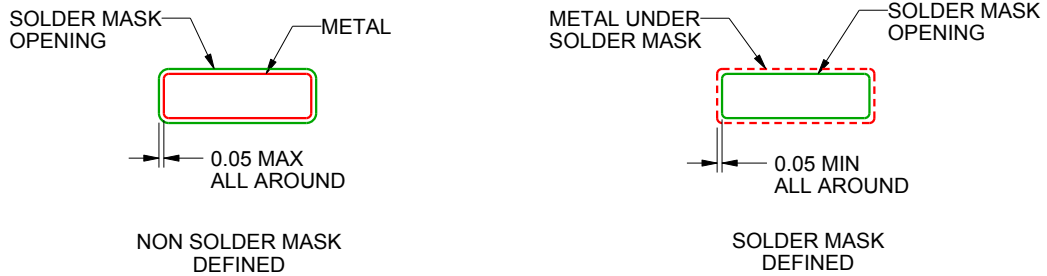
DGS0010A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
SCALE:10X



SOLDER MASK DETAILS
NOT TO SCALE

4221984/A 05/2015

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DGS0010A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:10X

4221984/A 05/2015

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
 - E. Falls within JEDEC MO-153

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE

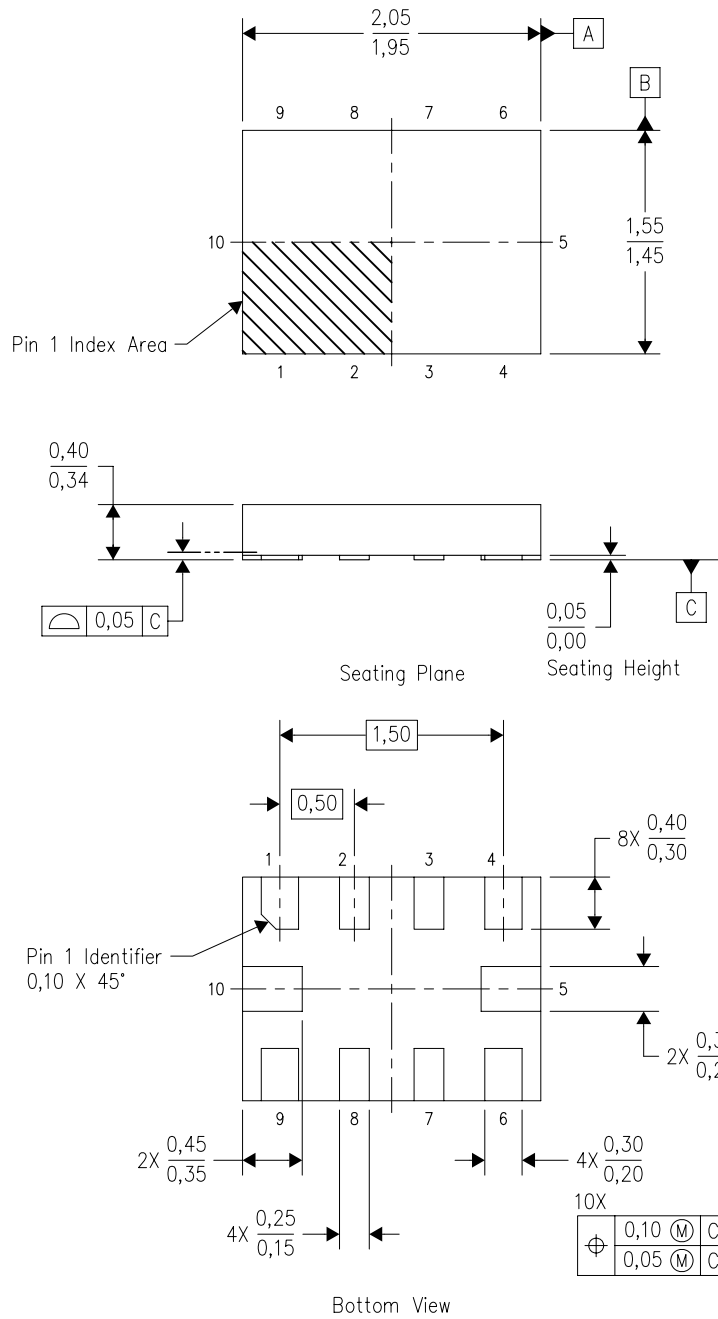


4211284-2/G 08/15

- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

RUG (R-PQFP-N10)

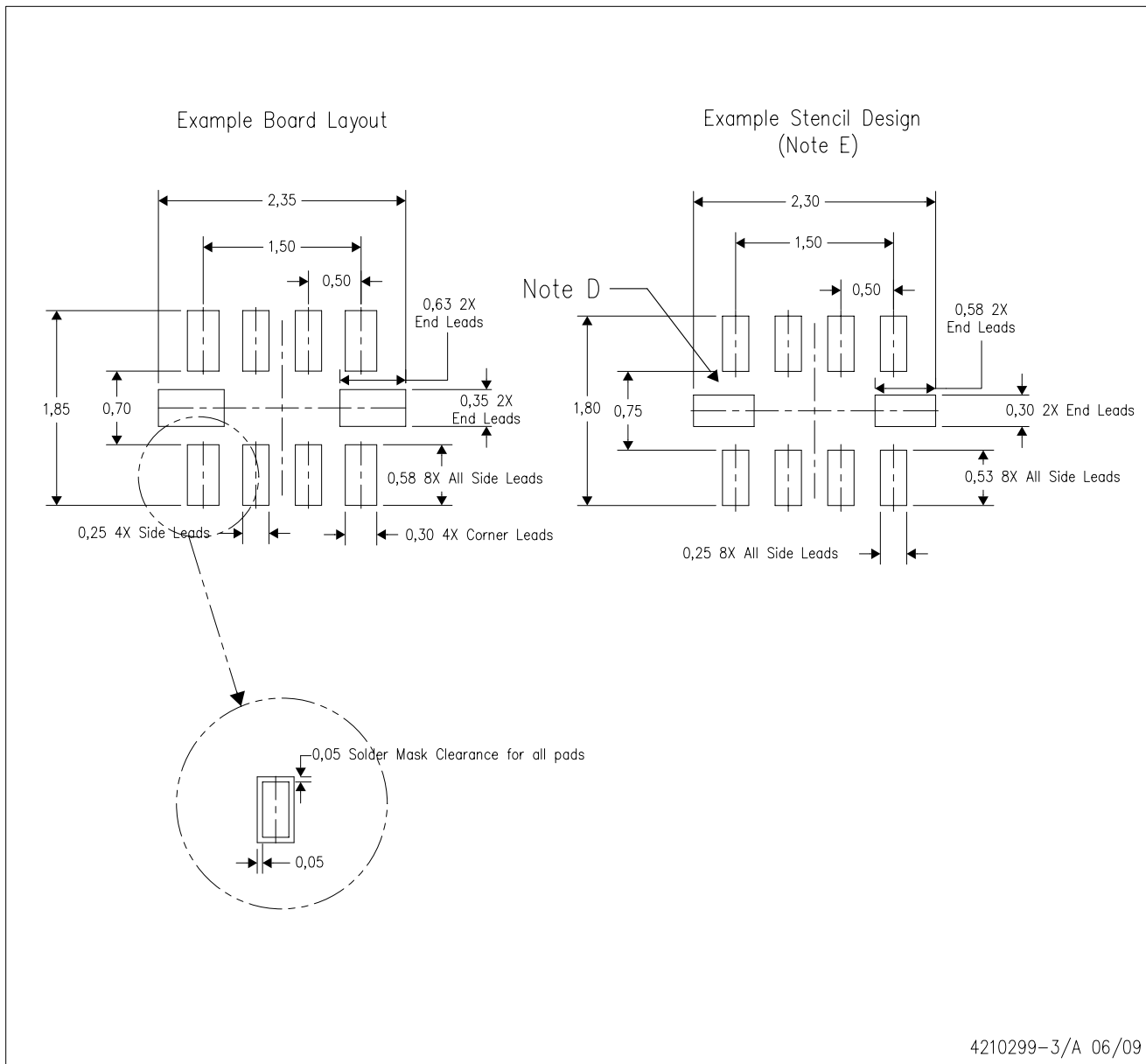
PLASTIC QUAD FLATPACK



4208528-3/B 04/2008

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. QFN (Quad Flatpack No-Lead) package configuration.
 - D. This package complies to JEDEC MO-288 variation X2EFD.

RUG (R-PQFP-N10)



4210299-3/A 06/09

- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.
 - E. Maximum stencil thickness 0,127 mm (5 mils). All linear dimensions are in millimeters.
 - F. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - G. Side aperture dimensions over-print land for acceptable area ratio > 0.66. Customer may reduce side aperture dimensions if stencil manufacturing process allows for sufficient release at smaller opening.

EXAMPLE BOARD LAYOUT

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE
 EXPOSED METAL SHOWN
 SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

GENERIC PACKAGE VIEW

DSG 8

WSON - 0.8 mm max height

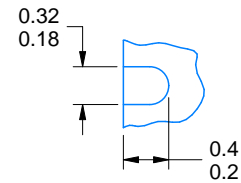
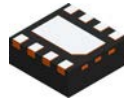
2 x 2, 0.5 mm pitch

PLASTIC SMALL OUTLINE - NO LEAD

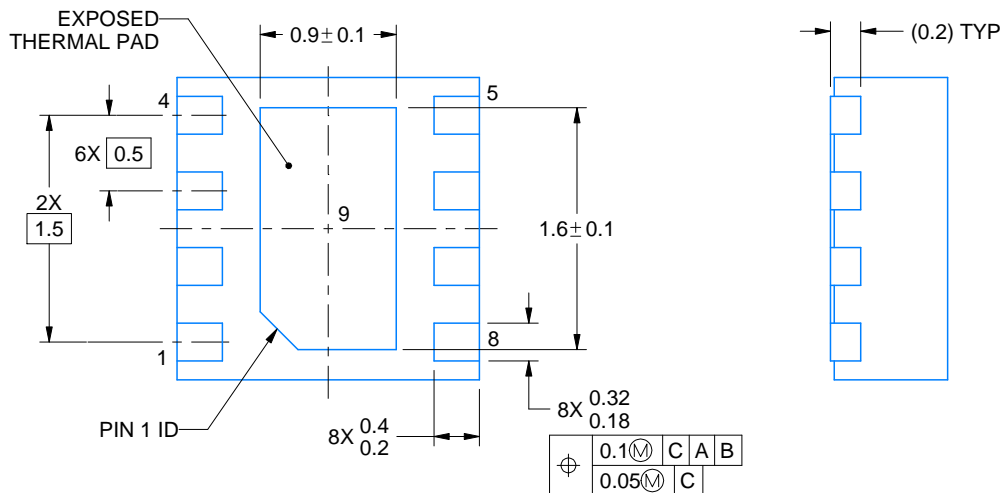
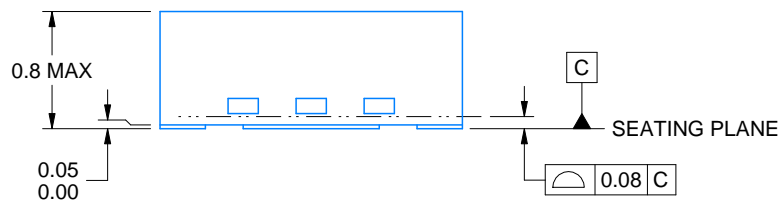
This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4224783/A



ALTERNATIVE TERMINAL SHAPE
TYPICAL



4218900/D 04/2020

NOTES:

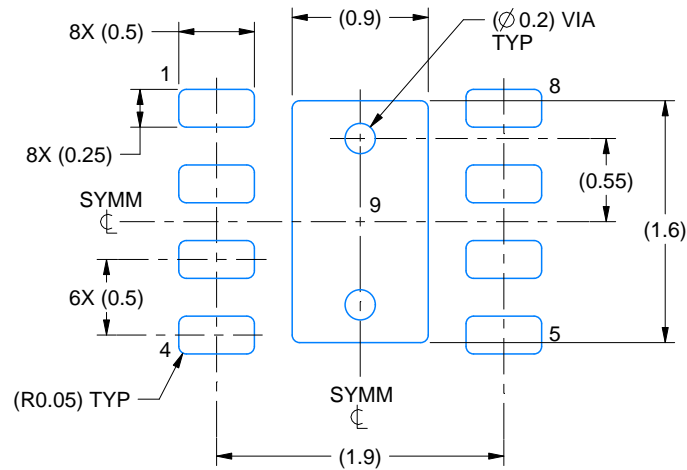
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

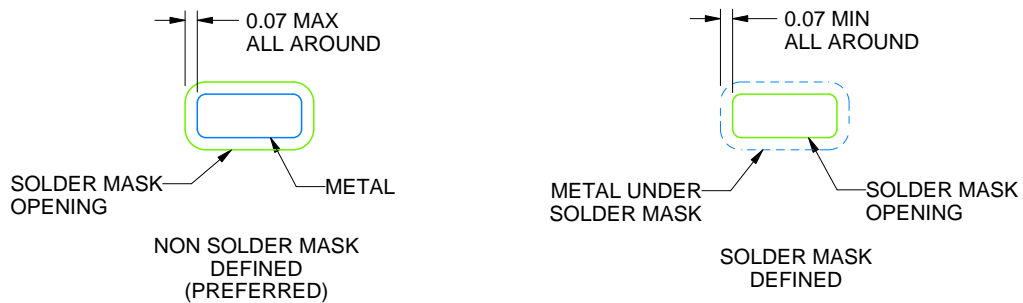
DSG0008A

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
SCALE:20X



SOLDER MASK DETAILS

4218900/D 04/2020

NOTES: (continued)

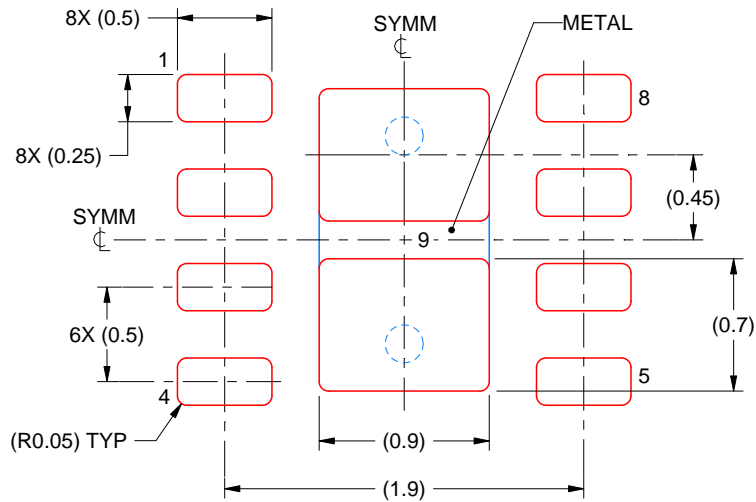
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

DSG0008A

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 9:
87% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:25X

4218900/D 04/2020

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

EXAMPLE BOARD LAYOUT

PW0008A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
SCALE:10X



SOLDER MASK DETAILS
NOT TO SCALE

4221848/A 02/2015

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0008A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

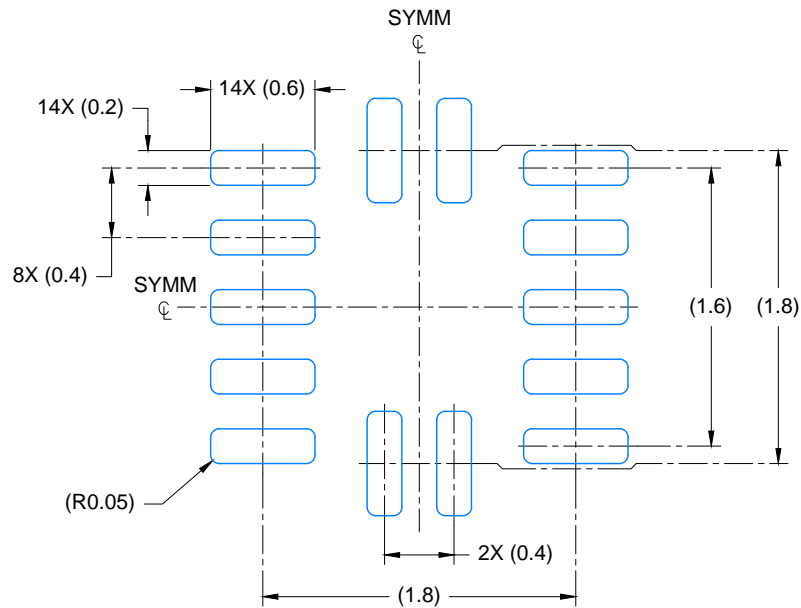


SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:10X

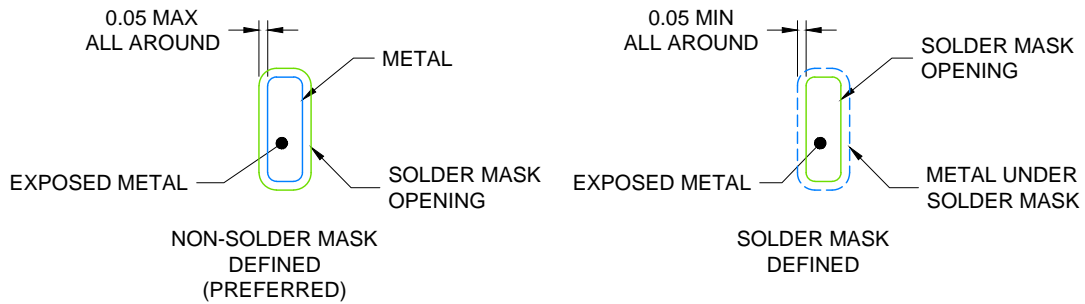
4221848/A 02/2015

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 23X



SOLDER MASK DETAILS

4220584/A 05/2019

NOTES: (continued)

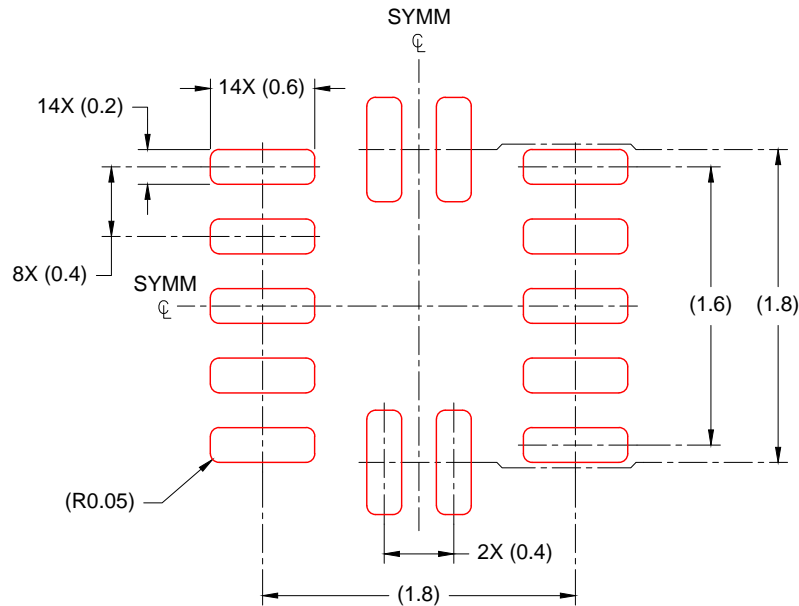
- For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

EXAMPLE STENCIL DESIGN

RUC0014A

X2QFN - 0.4 mm max height

PLASTIC QUAD FLAT PACK- NO LEAD



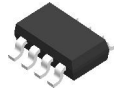
SOLDER PASTE EXAMPLE
BASED ON 0.100mm THICK STENCIL
SCALE: 23X

4220584/A 05/2019

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

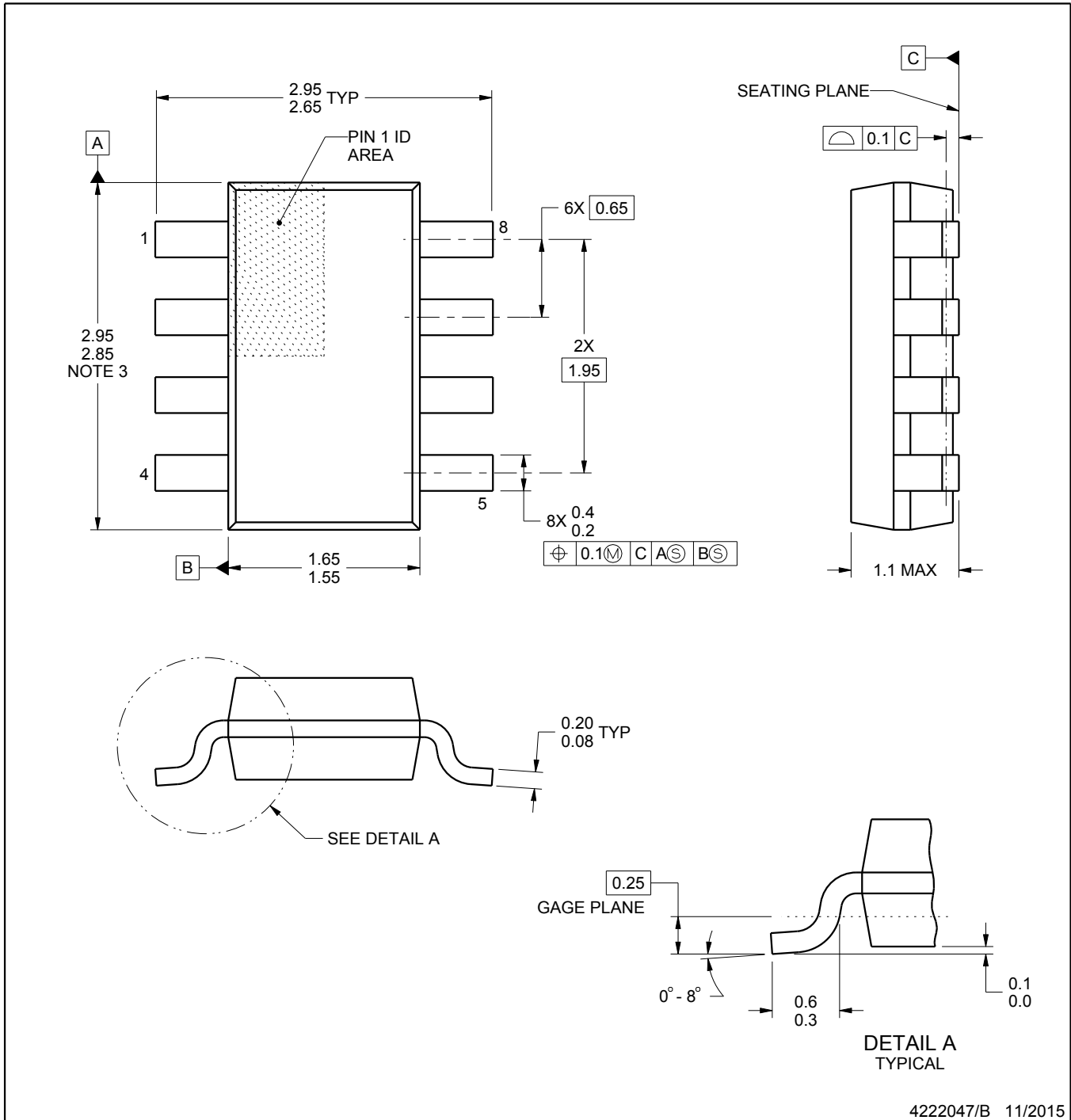
DDF0008A



PACKAGE OUTLINE

SOT-23 - 1.1 mm max height

PLASTIC SMALL OUTLINE



4222047/B 11/2015

NOTES:

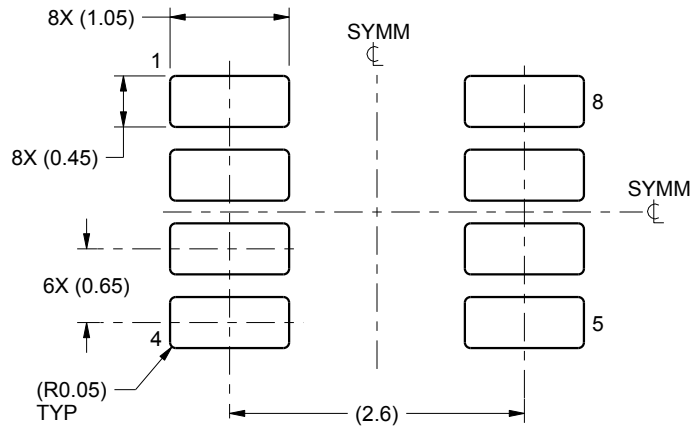
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.

EXAMPLE BOARD LAYOUT

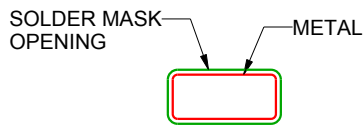
DDF0008A

SOT-23 - 1.1 mm max height

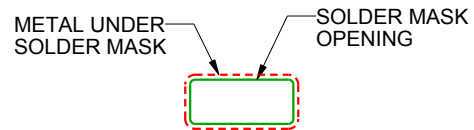
PLASTIC SMALL OUTLINE



LAND PATTERN EXAMPLE
SCALE:15X



NON SOLDER MASK
DEFINED



SOLDER MASK
DEFINED

SOLDER MASK DETAILS

4222047/B 11/2015

NOTES: (continued)

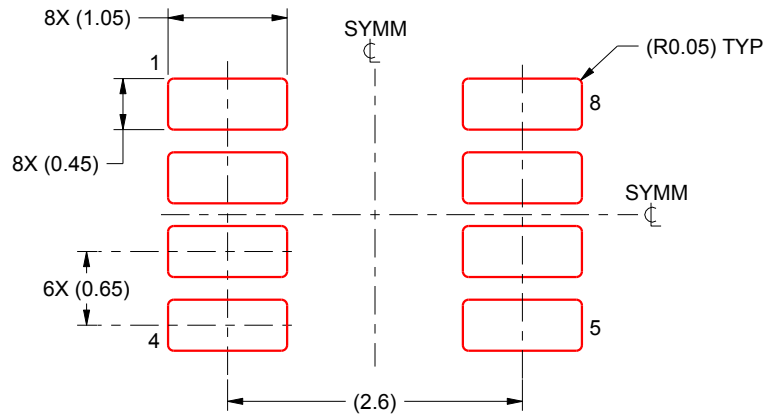
4. Publication IPC-7351 may have alternate designs.
5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DDF0008A

SOT-23 - 1.1 mm max height

PLASTIC SMALL OUTLINE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

4222047/B 11/2015

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
7. Board assembly site may have different recommendations for stencil design.

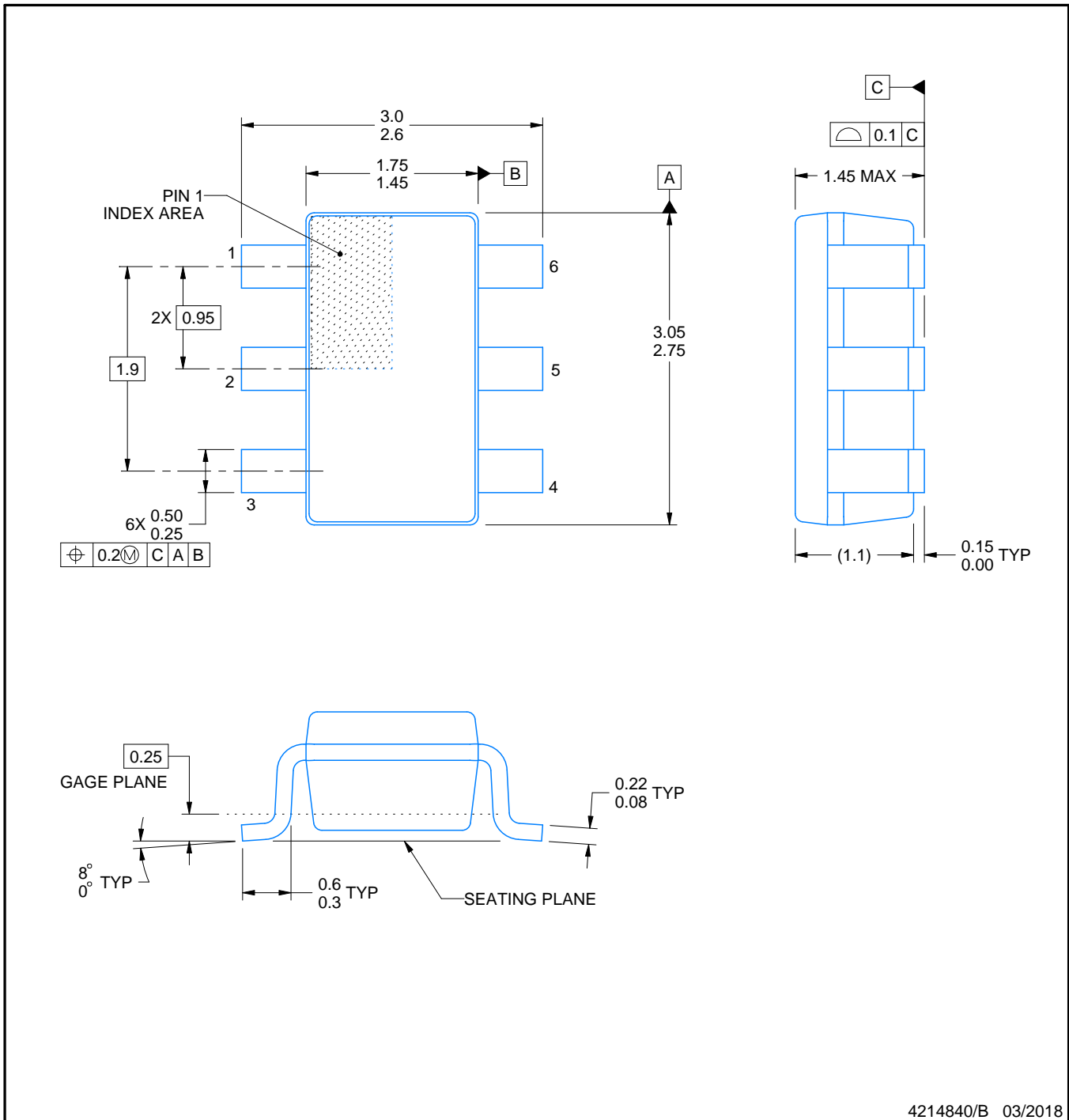
DBV0006A



PACKAGE OUTLINE

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



4214840/B 03/2018

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
4. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
5. Reference JEDEC MO-178.

EXAMPLE BOARD LAYOUT

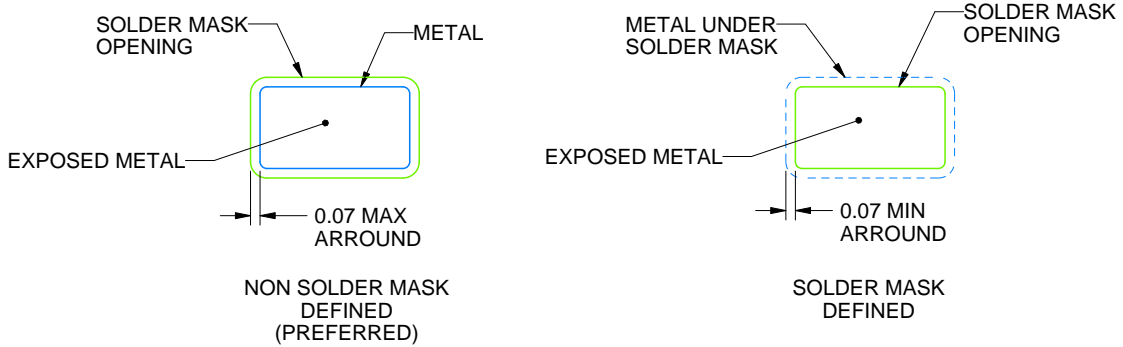
DBV0006A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

4214840/B 03/2018

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBV0006A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

4214840/B 03/2018

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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